

# CC2564MODx Bluetooth® Host Controller Interface (HCI) Module

## 1 Device Overview

### 1.1 Features

- Module Solution Based on TI's CC2564B Dual-Mode *Bluetooth* Single Chip With *Bluetooth* Basic Rate (BR), Enhanced Data Rate (EDR) and Low Energy (LE) Support; Available in Two Variants:
  - CC2564MODA With Integrated Antenna
  - CC2564MODN With External Antenna
- Fully Certified *Bluetooth* 4.1 Module
  - FCC (Z64-2564N)/IC (4511-2564N) Modular Grant (see [Section 6.2.1.3, Antenna](#), [Section 7.1.1, FCC Certification](#), and [Section 7.1.2 IC Certification](#))
  - CE Certified as Summarized in the [Declaration of Conformity](#) (see [Section 7.1.3, ETSI/CE Certification](#))
  - Bluetooth 4.1 Controller Subsystem Qualified (CC2564MODN: [QDID 55257](#); CC2564MODA: [QDID 64631](#)). Compliant up to the HCI Layer
- Highly Optimized for Design Into Small Form Factor Systems and Flexibility:
  - CC2564MODA
    - Integrated Chip Antenna
    - Module Footprint: 35 Terminals, 0.8-mm Pitch, 7 mm × 14 mm × 1.4 mm (Typ)
  - CC2564MODN
    - Single-Ended 50-Ω RF Interface
    - Module Footprint: 33 Terminals, 0.8-mm Pitch, 7 mm × 7 mm × 1.4 mm (Typ)
- BR/EDR Features Include:
  - Up to 7 Active Devices
  - Scatternet: Up to 3 Piconets Simultaneously, 1 as Master and 2 as Slaves
  - Up to 2 SCO Links on the Same Piconet
  - Support for All Voice Air-Coding – Continuously Variable Slope Delta (CVSD), A-Law, μ-Law, and Transparent (Uncoded)
  - Assisted Mode for HFP 1.6 Wideband Speech (WBS) Profile or A2DP Profile to Reduce Host Processing and Power
  - Support of Multiple *Bluetooth* Profiles With Enhanced QoS
- LE Features Include:
  - Support of Up to 10 Simultaneous Connections
  - Multiple Sniff Instances Tightly Coupled to Achieve Minimum Power Consumption
  - Independent Buffering for LE Allows Large Numbers of Multiple Connections Without Affecting BR/EDR Performance.
  - Built-In Coexistence and Prioritization Handling for BR/EDR and LE
- Best-in-Class *Bluetooth* (RF) Performance (TX Power, RX Sensitivity, Blocking)
  - Class 1.5 TX Power Up to +10 dBm
  - –93 dbm Typical RX Sensitivity
  - Internal Temperature Detection and Compensation to Ensure Minimal Variation in RF Performance Over Temperature, No External Calibration Required
  - Improved Adaptive Frequency Hopping (AFH) Algorithm With Minimum Adaptation Time
  - Provides Longer Range, Including 2x Range Over Other LE-Only Solutions
- Advanced Power Management for Extended Battery Life and Ease of Design
  - On-Chip Power Management, Including Direct Connection to Battery
  - Low Power Consumption for Active, Standby, and Scan *Bluetooth* Modes
  - Shutdown and Sleep Modes to Minimize Power Consumption
- Physical Interfaces:
  - UART Interface With Support for Maximum *Bluetooth* Data Rates
    - UART Transport Layer (H4) With Maximum Rate of 4 Mbps
    - Three-Wire UART Transport Layer (H5) With Maximum Rate of 4 Mbps
    - Fully Programmable Digital PCM-I2S Codec Interface
  - Flexibility for Easy Stack Integration and Validation Into Various Microcontrollers, Such as MSP430™ and ARM® Cortex®-M3 and Cortex®-M4 MCUs
  - CC256x *Bluetooth* Hardware Evaluation Tool: PC-Based Application to Evaluate RF Performance of the Device and Configure Service Pack
  - Lead-Free Design Compliant With RoHS Requirements



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## 1.2 Applications

- Mobile Accessories
- Sports and Fitness Applications
- Wireless Audio Solutions
- Remote Controls
- Toys
- Test and Measurement
- Industrial: Cable Replacement
- Wireless Sensors
- Automotive Aftermarket
- Point of Service (POS)
- Wellness and Health

## 1.3 Description

The TI CC2564MODx module is a complete *Bluetooth* BR/EDR/LE HCI solution based on TI's CC2564B dual-mode *Bluetooth* single-chip device, which reduces design effort and enables fast time to market. The CC2564MODx module includes TI's seventh-generation *Bluetooth* core and provides a product-proven solution that is *Bluetooth* 4.1 compliant. The CC2564MODx module provides best-in-class RF performance with a transmit power and receive sensitivity that provides range of about 2X compared to other BLE-only solutions. Furthermore, TI's power management hardware and software algorithms provide significant power savings in all commonly used *Bluetooth* BR/EDR/LE modes of operation.

The TI Dual-Mode *Bluetooth* Stack software is certified and provided royalty free for TI's MSP430 and ARM Cortex-M3 and Cortex-M4 MCUs. Other MPUs can be supported through TI's third party. iPod® (MFi) protocol is supported by add-on software packages. For more information, see [TI Dual-Mode Bluetooth Stack](#). Some of the profiles supported include the following:

- Serial port profile (SPP)
- Advanced audio distribution profile (A2DP)
- Audio/video remote control profile (AVRCP)
- Handsfree profile (HFP)
- Human interface device (HID)
- Generic attribute profile (GATT)
- Several *Bluetooth* LE profiles and services

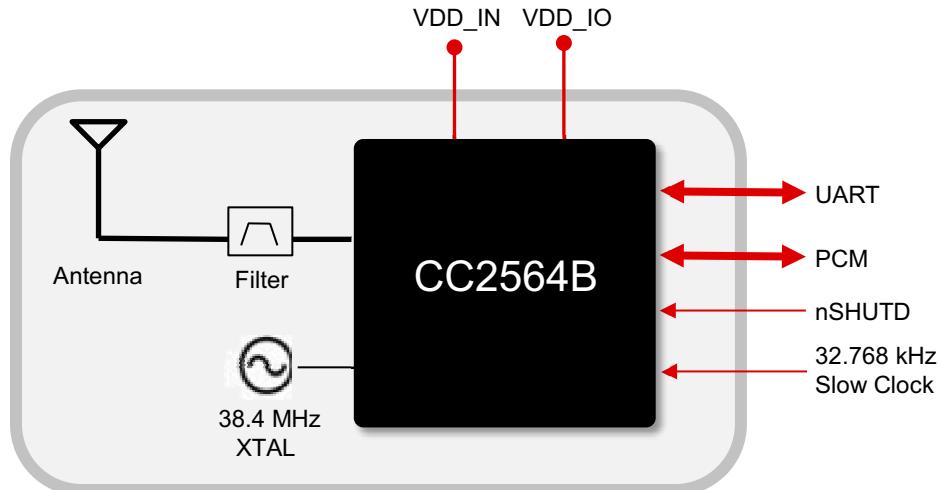
In addition to software, the CC2564MODxEM evaluation board is available for each variant. For more information on TI's wireless platform solutions for *Bluetooth*, see TI's [CC256x wiki](#).

**Device Information<sup>(1)</sup>**

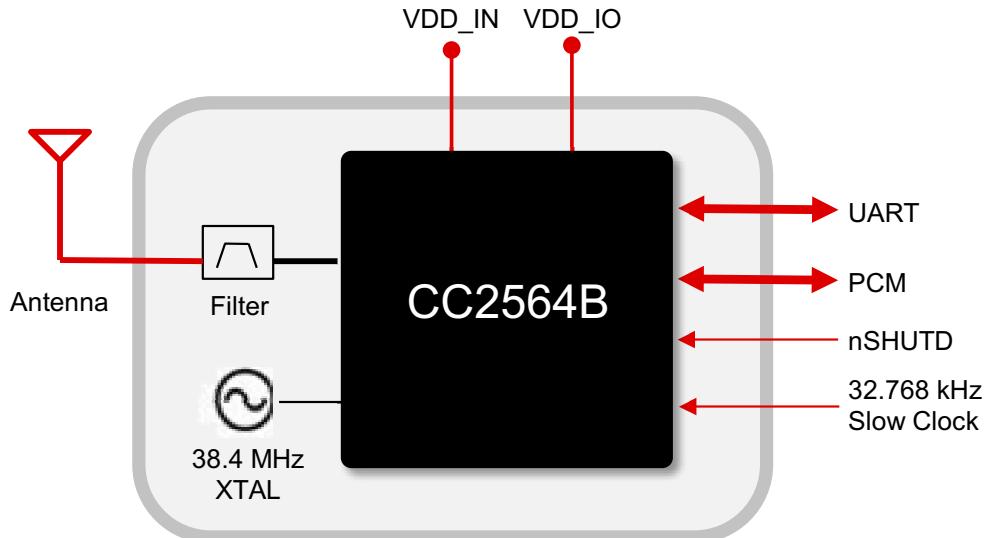
PART NUMBER	PACKAGE	BODY SIZE
CC2564MODNCMOET	MOE (33)	7.0 mm × 7.0 mm × 1.4 mm (Typ)
CC2564MODNCMOER	MOE (33)	7.0 mm × 7.0 mm × 1.4 mm (Typ)
CC2564MODACMOG	MOG (35)	7.0 mm × 14.0 mm × 1.4 mm (Typ)

(1) For more information on these devices, see [Section 8.2, Packaging and Ordering](#).

## 1.4 Functional Block Diagram



**Figure 1-1. CC2564MODA Functional Block Diagram**



**Figure 1-2. CC2564MODN Functional Block Diagram**

## 1.5 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

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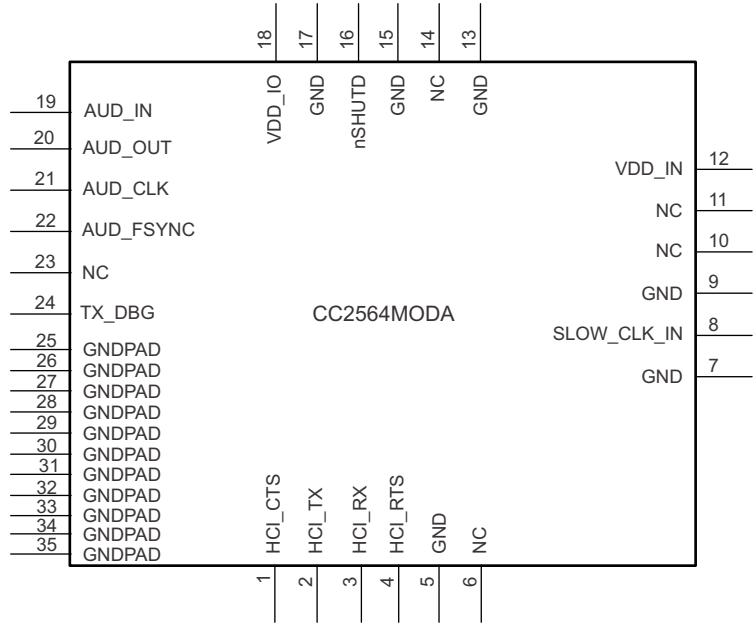
## 2 Revision History

Changes from Revision C (November 2015) to Revision D	Page
• Added CC2564MODA device variant	1
• Added applications in <a href="#">Section 1.2, Applications</a>	2
• Changed VBAT to VDD_IN <a href="#">Figure 5-1</a> and <a href="#">Figure 5-2</a>	3
• Changed storage temperature range in <a href="#">Section 4.1, Absolute Maximum Ratings</a>	7
• Changed restrictions on verification of parameters in <a href="#">Section 4.7.4.1, Bluetooth BR/EDR RF Performance</a>	14
• Changed restrictions on verification of parameters in <a href="#">Section 4.7.4.2, Bluetooth LE RF Performance</a>	16
• Changed values for Adjacent channel power $ M-N  = 2$ and Adjacent channel power $ M-N  > 2$ in <a href="#">Section 4.7.4.2.2, Bluetooth LE Transmitter</a>	16
• Added "Includes a 128-bit hardware encryption accelerator as defined by the Bluetooth specifications" in <a href="#">Section 5.4, Bluetooth BR/EDR Description</a>	18
• Changed <a href="#">Figure 5-10</a>	27
• Changed <a href="#">Figure 5-11</a>	28
• Changed <a href="#">Section 6.2.2.1, CC2564MODN Reference Design</a>	39

### 3 Terminal Configuration and Functions

#### 3.1 Pin Diagram

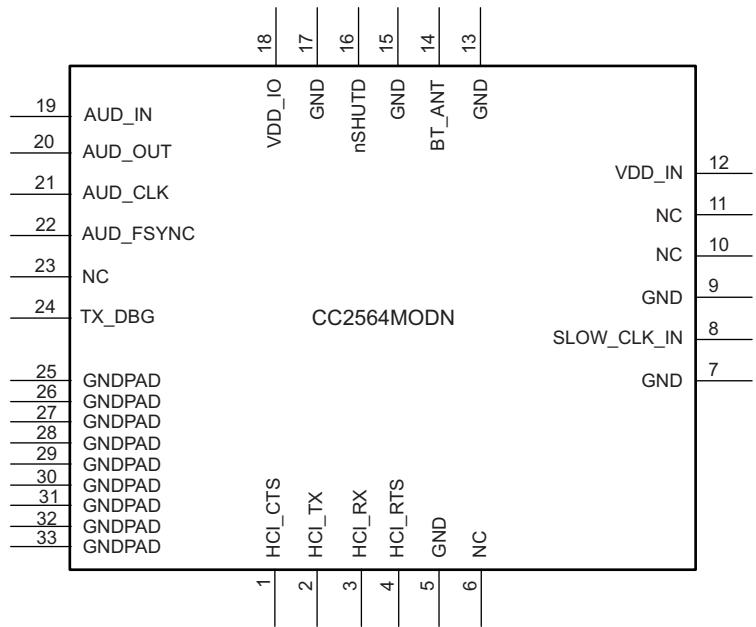
Figure 3-1 shows the top view of the terminal designations for the CC2564MODA device.



SWRS160-006

**Figure 3-1. CC2564MODA Pin Diagram (Top View)**

Figure 3-2 shows the top view of the terminal designations for the CC2564MODN device.



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**Figure 3-2. CC2564MODN Pin Diagram (Top View)**

### 3.2 Pin Attributes

Table 3-1 describes the pin attributes.

**Table 3-1. Pin Attributes**

NAME	NO.	ESD <sup>(1)</sup> (V)	PULL AT RESET	DEF. DIR. <sup>(2)</sup>	I/O Type <sup>(3)</sup>	DESCRIPTION	
HCI_CTS	1	750	PU	I	8 mA	HCI UART clear-to-send. The device can send data when HCI_CTS is low.	
HCI_TX	2	750	PU	O	8 mA	HCI UART data transmit	
HCI_RX	3	750	PU	I	8 mA	HCI UART data receive	
HCI_RTS	4	750	PU	O	8 mA	HCI UART request-to-send. Host can send data when HCI_RTS is low.	
GND	5	1000				Ground	
NC	6			I		Not connected	
GND	7	1000				Ground	
SLOW_CLK_IN	8	1000		I		32.768-kHz clock in	Fail-safe
GND	9	1000				Ground	
NC	10			O		Not connected	
NC	11			O		Not connected	
VDD_IN	12			I		Main power supply for the module (2.2 to 4.8 V)	
GND	13					Ground	
BT_ANT	14	500		IO		Bluetooth RF I/O (CC2564MODN only)	
NC						Not connected (CC2564MODA only)	
GND	15					Ground	
nSHUTD	16		PD	I		Shutdown input (active low)	
GND	17					Ground	
VDD_IO	18	1000		I		I/O power supply (1.8 V nominal)	
AUD_IN	19	500	PD	I	4 mA	PCM data input	Fail-safe
AUD_OUT	20	500	PD	O	4 mA	PCM data output	Fail-safe
AUD_CLK	21	500	PD	I/O	HY, 4 mA	PCM clock	Fail-safe
AUD_FSYNC	22	500	PD	I/O	4 mA	PCM frame sync	Fail-safe
NC	23	500	PD	I/O	4 mA	Not Connected	
TX_DBG	24	1000	PU	O	2 mA	TI internal debug messages. TI recommends leaving a test point.	
GNDPAD	25	1000				Ground	
GNDPAD	26	1000				Ground	
GNDPAD	27	1000				Ground	
GNDPAD	28	1000				Ground	
GNDPAD	29	1000				Ground	
GNDPAD	30	1000				Ground	
GNDPAD	31	1000				Ground	
GNDPAD	32	1000				Ground	
GNDPAD	33	1000				Ground	
GNDPAD	34	1000				Ground (CC2564MODA only)	
GNDPAD	35	1000				Ground (CC2564MODA only)	

(1) ESD: Human Body Model (HBM). JEDEC 22-A114 2-wire method. CDM: All pins pass 500 V except BT\_ANT, which passes 400 V.

(2) I = input; O = output; I/O = bidirectional

(3) I/O Type: Digital I/O cells. HY = input hysteresis, current = typical output current

## 4 Specifications

Unless otherwise indicated, all measurements are taken at the device pins of the TI test evaluation board (EVB). All specifications are over process, voltage, and temperature, unless otherwise indicated.

All values apply to the CC2564MODA and CC2564MODN devices, unless otherwise indicated.

### 4.1 Absolute Maximum Ratings<sup>(1)</sup>

Over operating free-air temperature range (unless otherwise indicated). All parameters are measured as follows: VDD\_IN = 3.6 V and VDD\_IO = 1.8 V (unless otherwise indicated).

PARAMETERS		MIN	MAX	UNIT
VDD_IN	Supply voltage range	-0.5	4.8	V
VDD_IO		-0.5	2.145	V
	Input voltage to analog pins <sup>(1)</sup>	-0.5	2.1	V
	Input voltage to all other pins	-0.5	VDD_IO + 0.5	V
	Operating ambient temperature range <sup>(2)</sup>	-30	85	°C
	Bluetooth RF inputs		10	dBm
Storage temperature range, T <sub>stg</sub>		-40	100	°C

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(1) Analog pin: BT\_ANT

(2) The module supports a temperature range of -30°C to 85°C because of the operating conditions of the crystal.

### 4.2 ESD Ratings

		VALUE	UNIT
V <sub>(ESD)</sub> electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±500	V
	Charged device model (CDM), per JEDEC specification JESD22- ±YYY V C101 <sup>(2)</sup>	±500	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 4.3 Power-On Hours<sup>(1)</sup>

DEVICE	CONDITIONS	POWER-ON HOURS
CC2564MODx	Duty Cycle = 25% active and 75% sleep T <sub>ambient</sub> = 70°C	15,400 (7 Years)

(1) This information is provided solely to give the customer an estimation of the POH under certain specified conditions, and is not intended to – and does not – extend the warranty for the device under TI's Standard Terms and Conditions.

### 4.4 Recommended Operating Conditions

RATING	CONDITION	SYM	MIN	MAX	UNIT
Power supply voltage		VDD_IN	2.2	4.8	V
I/O power supply voltage		VDD_IO	1.62	1.92	V
High-level input voltage	Default	V <sub>IH</sub>	0.65 x VDD_IO	VDD_IO	V
Low-level input voltage	Default	V <sub>IL</sub>	0	0.35 x VDD_IO	V
I/O input rise and fall times, 10% to 90% — asynchronous mode		t <sub>r</sub> and t <sub>f</sub>	1	10	ns
I/O input rise and fall times, 10% to 90% — synchronous mode (PCM)			1	2.5	ns
Voltage dips on VDD_IN (V <sub>BAT</sub> ) duration = 577 µs to 2.31 ms, period = 4.6 ms				400	mV
Maximum ambient operating temperature <sup>(1)</sup>			-30	85	°C

(1) A crystal-based solution is limited by the temperature range required for the crystal to meet 20 ppm.

## 4.5 Power Consumption Summary

### 4.5.1 Static Current Consumption

OPERATIONAL MODE	MIN	TYP	MAX	UNIT
Shutdown mode <sup>(1)</sup>		1	7	µA
Deep sleep mode <sup>(2)</sup>		40	105	µA
Total I/O current consumption in active mode			1	mA
Continuous transmission—GFSK <sup>(3)</sup>			107	mA
Continuous transmission—EDR <sup>(4)(5)</sup>			112.5	mA

(1)  $V_{BAT} + V_{IO} + V_{SHUTDOWN}$

(2)  $V_{BAT} + V_{IO}$

(3) At maximum output power (10 dBm)

(4) At maximum output power (8 dBm)

(5) Both π/4 DQPSK and 8DPSK

### 4.5.2 Dynamic Current Consumption

#### 4.5.2.1 Current Consumption for Different Bluetooth BR/EDR Scenarios

Conditions: VDD\_IN = 3.6 V, 25°C, nominal unit, 8-dBm output power

OPERATIONAL MODE	MASTER AND SLAVE	AVERAGE CURRENT	UNIT
Synchronous connection oriented (SCO) link HV3	Master and slave	13.7	mA
Extended SCO (eSCO) link EV3 64 kbps, no retransmission	Master and slave	13.2	mA
eSCO link 2-EV3 64 kbps, no retransmission	Master and slave	10	mA
GFSK full throughput: TX = DH1, RX = DH5	Master and slave	40.5	mA
EDR full throughput: TX = 2-DH1, RX = 2-DH5	Master and slave	41.2	mA
EDR full throughput: TX = 3-DH1, RX = 3-DH5	Master and slave	41.2	mA
Sniff, four attempts, 1.28 seconds	Master and slave	145	µA
Page or inquiry scan 1.28 seconds, 11.25 ms	Master and slave	320	µA
Page (1.28 seconds) and inquiry (2.56 seconds) scans, 11.25 ms	Master and slave	445	µA
A2DP source	Master	13.9	mA
A2DP sink	Master	15.2	mA
Assisted A2DP source	Master	16.9	mA
Assisted A2DP sink	Master	18.1	mA
Assisted WBS EV3; retransmit effort = 2; maximum latency = 8 ms	Master and slave	17.5 and 18.5	mA
Assisted WBS 2EV3; retransmit effort = 2; maximum latency = 12 ms	Master and slave	11.9 and 13	mA

#### 4.5.2.2 Current Consumption for Different LE Scenarios

Conditions: VDD\_IN = 3.6 V, 25°C, nominal unit, 8-dBm output power

MODE	DESCRIPTION	AVERAGE CURRENT	UNIT
Advertising, nonconnectable	Advertising in all three channels 1.28-seconds advertising interval 15 bytes advertise data	114	µA
Advertising, discoverable	Advertising in all three channels 1.28-seconds advertising interval 15 bytes advertise data	138	µA

MODE	DESCRIPTION	AVERAGE CURRENT	UNIT
Scanning	Listening to a single frequency per window 1.28-seconds scan interval 11.25-ms scan window	324	µA
Connected (master role)	500-ms connection interval 0-ms slave connection latency	169 (master)	µA
Connected (slave role)	Empty TX and RX LL packets	199 (slave)	

## 4.6 Electrical Characteristics

RATING		CONDITION	MIN	MAX	UNIT
High-level output voltage, V <sub>OH</sub>		At 2, 4, 8 mA	0.8 x VDD <sub>IO</sub>	VDD <sub>IO</sub>	V
		At 0.1 mA	VDD <sub>IO</sub> – 0.2	VDD <sub>IO</sub>	
Low-level output voltage, V <sub>OL</sub>		At 2, 4, 8 mA	0	0.2 x VDD <sub>IO</sub>	V
		At 0.1 mA	0	0.2	
I/O input impedance		Resistance	1		MΩ
		Capacitance		5	pF
Output rise and fall times, 10% to 90% (digital pins)		C <sub>L</sub> = 20 pF		10	ns
I/O pull currents	PCM-I2S bus, TX_DBG	PU	typ = 6.5	3.5	9.7
		PD	typ = 27	9.5	55
	All others	PU	typ = 100	50	300
		PD	typ = 100	50	360

## 4.7 Timing and Switching Characteristics

### 4.7.1 Device Power Supply

The power-management hardware and software algorithms of the TI *Bluetooth* HCI module provide significant power savings, which is a critical parameter in an MCU-based system.

The power-management module is optimized for drawing extremely low currents.

#### 4.7.1.1 Power Sources

The TI *Bluetooth* HCI module requires two power sources:

- VDD\_IN: main power supply for the module
- VDD\_IO: power source for the 1.8-V I/O ring

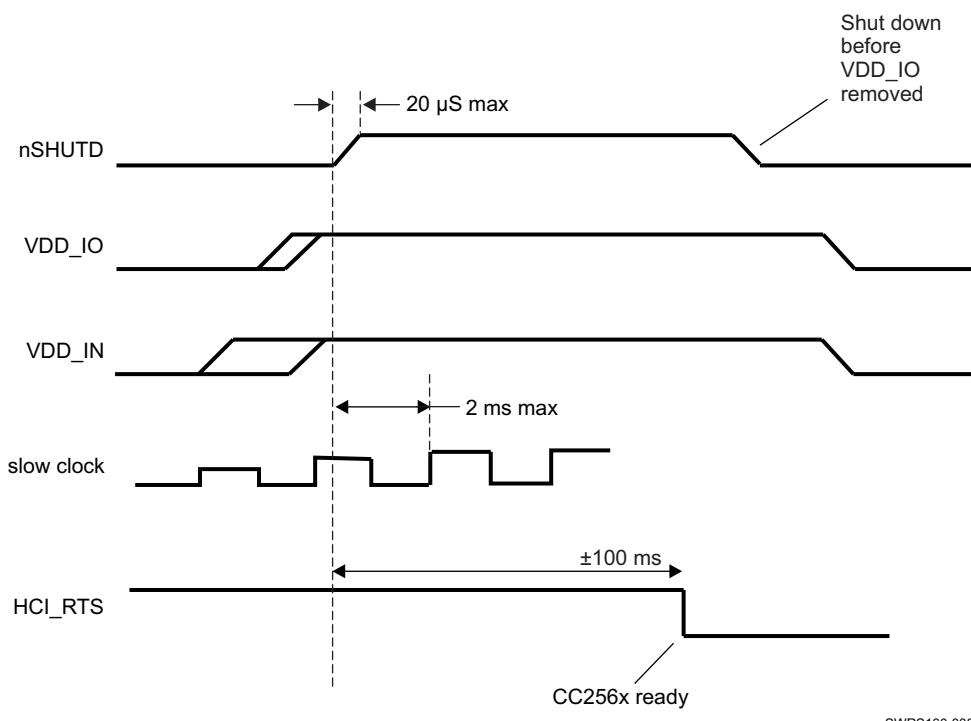
The HCI module includes several on-chip voltage regulators for increased noise immunity and can be connected directly to the battery.

#### 4.7.1.2 Power Supply Sequencing

The device includes the following power-up requirements (see [Figure 4-1](#)):

- nSHUTD must be low. VDD\_IN and VDD\_IO are don't-care when nSHUTD is low. However, signals are not allowed on the I/O pins if I/O power is not supplied, because the I/Os are not fail-safe. Exceptions are SLOW\_CLK\_IN and AUD\_xxx, which are fail-safe and can tolerate external voltages with no VDD\_IO and VDD\_IN.
- VDD\_IO and VDD\_IN must be stable before releasing nSHUTD.
- The slow clock must be stable within 2 ms of nSHUTD going high.

The device indicates that the power-up sequence is complete by asserting RTS low, which occurs up to 100 ms after nSHUTD goes high. If RTS does not go low, the device is not powered up. In this case, ensure that the sequence and requirements are met.



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**Figure 4-1. Power-Up and Power-Down Sequence**

#### 4.7.1.3 Power Supplies and Shutdown – Static States

The nSHUTD signal puts the device in ultra-low power mode and performs an internal reset to the device. The rise time for nSHUTD must not exceed 20  $\mu\text{s}$ ; nSHUTD must be low for a minimum of 5 ms.

To prevent conflicts with external signals, all I/O pins are set to the high-impedance (Hi-Z) state during shutdown and power up of the device. The internal pull resistors are enabled on each I/O pin, as described in [Section 3.2, Pin Attributes](#). [Table 4-1](#) describes the static operation states.

**Table 4-1. Power Modes**

	VDD_IN <sup>(1)</sup>	VDD_IO <sup>(1)</sup>	nSHUTD <sup>(1)</sup>	PM_MODE	COMMENTS
1	None	None	Asserted	Shut down	I/O state is undefined. I/O voltages are not allowed on nonfail-safe pins.
2	None	None	Deasserted	Not allowed	I/O state is undefined. I/O voltages are not allowed on nonfail-safe pins.
3	None	Present	Asserted	Shut down	I/Os are defined as 3-state with internal pullup or pulldown enabled.
4	None	Present	Deasserted	Not allowed	I/O state is undefined. I/O voltages are not allowed on nonfail-safe pins.
5	Present	None	Asserted	Shut down	I/O state is undefined.
6	Present	None	Deasserted	Not allowed	I/O state is undefined. I/O voltages are not allowed on nonfail-safe pins.
7	Present	Present	Asserted	Shut down	I/Os are defined as 3-state with internal pullup or pulldown enabled.
8	Present	Present	Deasserted	Active	See <a href="#">Section 4.7.1.4, I/O States in Various Power Modes</a>

(1) The terms *None* or *Asserted* can imply any of the following conditions: directly pulled to ground or driven low, pulled to ground through a pulldown resistor, or left NC or floating (high-impedance output stage).

#### 4.7.1.4 I/O States in Various Power Modes

**CAUTION**

Some device I/Os are not fail-safe (see [Section 3.2, Pin Attributes](#)). Fail-safe means that the pins do not draw current from an external voltage applied to the pin when I/O power is not supplied to the device. External voltages are not allowed on these I/O pins when the I/O supply voltage is not supplied because of possible damage to the device.

[Table 4-2](#) lists the I/O states in various power modes.

**Table 4-2. I/O States in Various Power Modes**

I/O NAME	SHUT DOWN <sup>(1)</sup>		DEFAULT ACTIVE <sup>(1)</sup>		DEEP SLEEP <sup>(1)</sup>	
	I/O State	Pull	I/O State	Pull	I/O State	Pull
HCI_RX	Z	PU	I	PU	I	PU
HCI_TX	Z	PU	O-H		O	
HCI_RTS	Z	PU	O-H		O	
HCI_CTS	Z	PU	I	PU	I	PU
AUD_CLK	Z	PD	I	PD	I	PD
AUD_FSYNC	Z	PD	I	PD	I	PD
AUD_IN	Z	PD	I	PD	I	PD
AUD_OUT	Z	PD	Z	PD	Z	PD
TX_DBG	Z	PU	O			

(1) I = input, O = output, Z = Hi-Z, — = no pull, PU = pullup, PD = pulldown, H = high, L = low

#### 4.7.1.5 nSHUTD Requirements

PARAMETER	SYM	MIN	MAX	UNIT
Operation mode level <sup>(1)</sup>	$V_{IH}$	1.42	1.98	V
Shutdown mode level <sup>(1)</sup>	$V_{IL}$	0	0.4	V
Minimum time for nSHUT_DOWN low to reset the device		5		ms
Rise and fall times	$t_r$ and $t_f$		20	$\mu s$

(1) An internal 300-k $\Omega$  pulldown retains shut-down mode when no external signal is applied to this pin.

#### 4.7.2 Clock Specifications

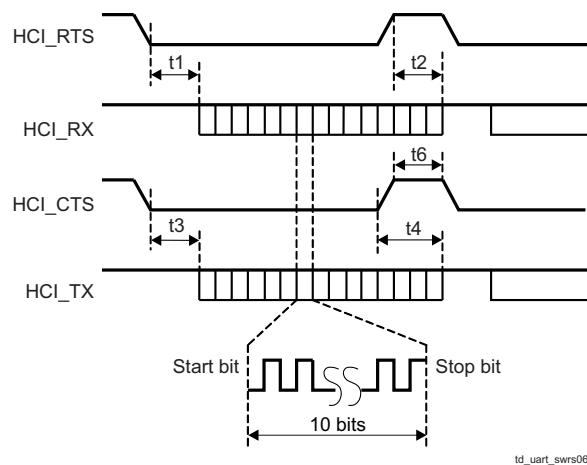
##### 4.7.2.1 Slow Clock Requirements

CHARACTERISTICS	CONDITION	SYM	MIN	TYP	MAX	UNIT
Input slow clock frequency				32768		Hz
Input slow clock accuracy (Initial + temp + aging)	Bluetooth			$\pm 250$	$\pm 50$	ppm
	ANT			$\pm 50$		
Input transition time $t_r$ and $t_f$ (10% to 90%)		$t_r$ and $t_f$			200	ns
Frequency input duty cycle			15%	50%	85%	
Slow clock input voltage limits	Square wave, DC-coupled	$V_{IH}$	$0.65 \times VDD\_IO$		$VDD\_IO$	V peak
		$V_{IL}$	0	$0.35 \times VDD\_IO$		V peak
Input impedance			1			M $\Omega$
Input capacitance					5	pF

### 4.7.3 Peripherals

#### 4.7.3.1 UART

Figure 4-2 shows the UART timing diagram.



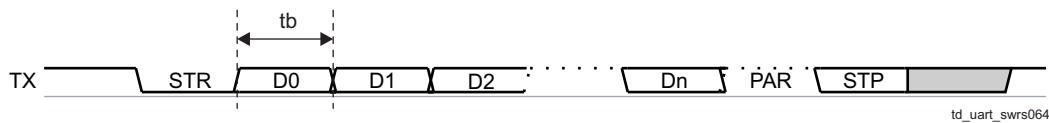
**Figure 4-2. UART Timing**

Table 4-3 lists the UART timing characteristics.

**Table 4-3. UART Timing Characteristics**

SYMBOL	CHARACTERISTICS	CONDITION	MIN	TYP	MAX	UNIT
	Baud rate		37.5	4000	4000	kbps
	Baud rate accuracy per byte	Receive and transmit	-2.5	1.5%	1.5%	
	Baud rate accuracy per bit	Receive and transmit	-12.5	12.5%	12.5%	
t3	CTS low to TX_DATA on		0	2	2	μs
t4	CTS high to TX_DATA off	Hardware flow control			1	byte
t6	CTS-high pulse width		1		1	bit
t1	RTS low to RX_DATA on		0	2	2	μs
t2	RTS high to RX_DATA off	Interrupt set to 1/4 FIFO			16	byte

Figure 4-3 shows the UART data frame.



**Figure 4-3. Data Frame**

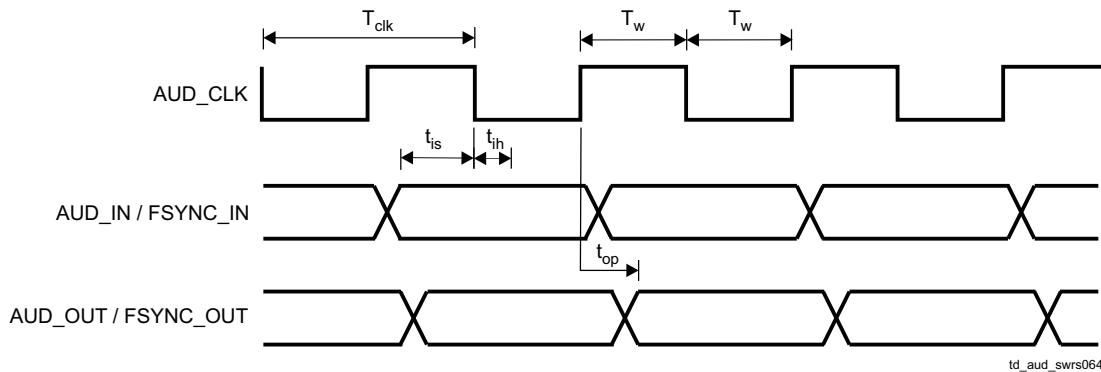
Table 4-4 describes the symbols used in Figure 4-3.

**Table 4-4. Data Frame Key**

SYMBOL	DESCRIPTION
STR	Start bit
D0...Dn	Data bits (LSB first)
PAR	Parity bit (optional)
STP	Stop bit

#### 4.7.3.2 PCM

Figure 4-4 shows the interface timing for the PCM.



**Figure 4-4. PCM Interface Timing**

Table 4-5 lists the associated PCM master parameters.

**Table 4-5. PCM Master**

Symbol	PARAMETER	CONDITION	MIN	MAX	UNIT
T <sub>clk</sub>	Cycle time		244.14 (4.096 MHz)	15625 (64 kHz)	ns
T <sub>w</sub>	High or low pulse width		50% of T <sub>clk</sub> min		
t <sub>is</sub>	AUD_IN setup time		25		
t <sub>iH</sub>	AUD_IN hold time		0		
t <sub>op</sub>	AUD_OUT propagation time	40-pF load	0	10	
t <sub>op</sub>	FSYNC_OUT propagation time	40-pF load	0	10	

Table 4-6 lists the associated PCM slave parameters.

**Table 4-6. PCM Slave**

SYMBOL	PARAMETER	CONDITION	MIN	MAX	UNIT
T <sub>clk</sub>	Cycle time		66.67 (15 MHz)		ns
T <sub>w</sub>	High or low pulse width		40% of T <sub>clk</sub>		
T <sub>is</sub>	AUD_IN setup time		8		
T <sub>iH</sub>	AUD_IN hold time		0		
t <sub>is</sub>	AUD_FSYNC setup time		8		
t <sub>iH</sub>	AUD_FSYNC hold time		0		
t <sub>op</sub>	AUD_OUT propagation time	40-pF load	0	21	

## 4.7.4 RF Performance

### 4.7.4.1 Bluetooth BR/EDR RF Performance

All parameters in this section are verified using a 38.4-MHz XTAL and an RF load of  $50\ \Omega$  at the BT\_ANT port. These parameters are verified in a conducted mode and do not include antenna performance.

#### 4.7.4.1.1 Bluetooth Receiver—In-Band Signals

CHARACTERISTICS	CONDITION		MIN	TYP	MAX	BLUETOOTH SPECIFICATION	UNIT
Operation frequency range			2402		2480		MHz
Channel spacing				1			MHz
Input impedance				50			$\Omega$
Sensitivity, dirty TX on <sup>(1)</sup>	GFSK, BER = 0.1%			-93		-70	dBm
	Pi/4-DQPSK, BER = 0.01%			-92.5		-70	
	8DPSK, BER = 0.01%			-85.5		-70	
BER error floor at sensitivity + 10 dB, dirty TX off	Pi/4-DQPSK			1E-7		1E-5	
	8DPSK					1E-5	
Maximum usable input power	GFSK, BER = 0.1%			-5		-20	dBm
	Pi/4-DQPSK, BER = 0.1%			-10			
	8DPSK, BER = 0.1%			-10			
Intermodulation characteristics	Level of interferers (for n = 3, 4, and 5)			-30		-39	dBm
C/I performance <sup>(2)</sup>  Image = -1 MHz	GFSK, co-channel			8		11	dB
	EDR, co-channel	Pi/4-DQPSK		9.5		13	
		8DPSK		16.5		21	
	GFSK, adjacent $\pm 1$ MHz			-10		0	
	EDR, adjacent $\pm 1$ MHz, (image)	Pi/4-DQPSK		-10		0	
		8DPSK		-5		5	
	GFSK, adjacent $+2$ MHz			-38		-30	
	EDR, adjacent, $+2$ MHz	Pi/4-DQPSK		-38		-30	
		8DPSK		-38		-25	
	GFSK, adjacent $-2$ MHz			-28		-20	
	EDR, adjacent $-2$ MHz	Pi/4-DQPSK		-28		-20	
		8DPSK		-22		-13	
	GFSK, adjacent $\geq  \pm 3 $ MHz			-45		-40	
	EDR, adjacent $\geq  \pm 3 $ MHz	Pi/4-DQPSK		-45		-40	
		8DPSK		-44		-33	
RF return loss				-10			dB
RX mode LO leakage	Fr <sub>f</sub> = (received RF – 0.6 MHz)			-63			dBm

- (1) Sensitivity degradation up to 3 dB may occur for minimum and typical values where the Bluetooth frequency is a harmonic of the fast clock.  
(2) Numbers show ratio of desired signal to interfering signal. Smaller numbers indicate better C/I performance.

#### 4.7.4.1.2 Bluetooth Transmitter—GFSK

CHARACTERISTICS	MIN	TYP	MAX	BLUETOOTH SPECIFICATION	UNIT
Maximum RF output power <sup>(1)</sup>		10			dBm
Gain control range		30			dB
Power control step	2		8	2 to 8	
Adjacent channel power  M–N  = 2		-35		$\leq -20$	dBm
Adjacent channel power  M–N  > 2		-45		$\leq -40$	

- (1) To modify maximum output power, use an HCI VS command.

#### 4.7.4.1.3 Bluetooth Transmitter—EDR

CHARACTERISTICS			MIN	TYP	MAX	BLUETOOTH SPECIFICATION	UNIT
EDR output power	Pi/4-DQPSK	VDD_IN = V <sub>BAT</sub>		8			dBm
	8DPSK	VDD_IN = V <sub>BAT</sub>		8			
EDR relative power			-2	1	-4 to +1		dB
Gain control range				30			
Power control step			2	8	2 to 8		
Adjacent channel power  M-N  = 1				-30		≤ -26	dBc
Adjacent channel power  M-N  = 2				-23		≤ -20	dBm
Adjacent channel power  M-N  > 2 <sup>(1)</sup>				-42		≤ -40	dBm

(1) Adjacent channel power measurements take into account specification exception of three bands, as defined by the *Test Suite Structure (TSS) and Test Purposes (TP) Bluetooth Documentation Specification*.

#### 4.7.4.1.4 Bluetooth Modulation—GFSK

CHARACTERISTICS	CONDITION		SYM	MIN	TYP	MAX	BLUETOOTH SPECIFICATION	UNIT
-20 dB bandwidth	GFSK			925			≤ 1000	kHz
Modulation characteristics	Δf1avg	Mod data = 4 1 s, 4 0 s: 111100001111...	F1 avg	165		140 to 175	kHz	
	Δf2max ≥ limit for at least 99.9% of all Δf2max	Mod data = 1010101...	F2 max	130		> 115		
	Δf2avg, Δf1avg			88%		> 80%		
Absolute carrier frequency drift	DH1			-25	25	< ±25	kHz	
	DH3 and DH5			-35	35	< ±40		
Drift rate					20	< 20	kHz/ 50 μs	
Initial carrier frequency tolerance	f0 – f <sub>TX</sub>			-75	+75	< ±75	kHz	

#### 4.7.4.1.5 Bluetooth Modulation—EDR

CHARACTERISTICS	CONDITION	MIN	TYP	MAX	BLUETOOTH SPECIFICATION	UNIT
Carrier frequency stability		-10	10		≤ 10	kHz
Initial carrier frequency tolerance		-75	75		±75	kHz
Rms DEVM <sup>(1)</sup>	Pi/4-DQPSK		6%		20%	
	8DPSK		6%		13%	
99% DEVM <sup>(1)</sup>	Pi/4-DQPSK			30%	30%	
	8DPSK			20%	20%	
Peak DEVM <sup>(1)</sup>	Pi/4-DQPSK		14%		35%	
	8DPSK		16%		25%	

(1) Max performance refers to maximum TX power.

#### 4.7.4.2 Bluetooth LE RF Performance

All parameters in this section are verified using a 38.4-MHz XTAL and an RF load of  $50\ \Omega$  at the BT\_ANT port. These parameters are verified in a conducted mode and do not include antenna performance.

##### 4.7.4.2.1 Bluetooth LE Receiver—In-Band Signals

CHARACTERISTIC	CONDITION	MIN	TYP	MAX	BLE SPECIFICATION	UNIT
Operation frequency range		2402		2480		MHz
Channel spacing			2			MHz
Input impedance			50			$\Omega$
Sensitivity, dirty TX on <sup>(1)</sup>	PER = 30.8%; dirty TX on		-93		$\leq -70$	dBm
Maximum usable input power	GMSK, PER = 30.8%	-10			$\geq -10$	dBm
Intermodulation characteristics	Level of interferers (for $n = 3, 4, 5$ )		-30		$\geq -50$	dBm
C/I performance <sup>(2)</sup> Image = -1 MHz	GMSK, co-channel		8		$\leq 21$	dB
	GMSK, adjacent $\pm 1$ MHz		-5		$\leq 15$	
	GMSK, adjacent +2 MHz		-45		$\leq -17$	
	GMSK, adjacent -2 MHz		-22		$\leq -15$	
	GMSK, adjacent $\geq  \pm 3 $ MHz		-47		$\leq -27$	
RX mode LO leakage	$F_{rf} = (\text{received RF} - 0.6\ \text{MHz})$	-63				dBm

(1) Sensitivity degradation up to 3 dB may occur where the BLE frequency is a harmonic of the fast clock.

(2) Numbers show wanted signal-to-interfering signal ratio. Smaller numbers indicate better C/I performance.

##### 4.7.4.2.2 Bluetooth LE Transmitter

CHARACTERISTICS		MIN	TYP	MAX	BLE SPECIFICATION	UNIT
RF output power (VDD_IN = VBAT) <sup>(1)</sup>	CC2564MODN		10		$\leq 10$	dBm
	CC2564MODA		8 <sup>(2)</sup>		$\leq 10$	
Adjacent channel power $ M-N  = 2$			-35		$\leq -20$	dBm
Adjacent channel power $ M-N  > 2$			-45		$\leq -30$	

(1) To modify maximum output power, use an HCI VS command.

(2) Required to meet the power spectral density (PSD) as defined by clause 5.3.3.2 in ETSI EN 300 328 V1.9.1. The integrated antenna gain is 1.69 dBi.

##### 4.7.4.2.3 Bluetooth LE Modulation

CHARACTERISTICS	CONDITION		SYM	MIN	TYP	MAX	BLE SPEC.	UNIT
Modulation characteristics	$\Delta f_{1avg}$	Mod data = 4 1s, 4 0 s: 1111000011110000...	$\Delta f_{1avg}$	250		225 to 275	kHz	
	$\Delta f_{2max} \geq$ limit for at least 99.9% of all $\Delta f_{2max}$	Mod data = 1010101...	$\Delta f_{2max}$	210		$\geq 185$		
	$\Delta f_{2avg}, \Delta f_{1avg}$			0.9		$\geq 0.8$		
Absolute carrier frequency drift				-25	25		$\leq \pm 50$	kHz
Drift rate					15		$\leq 20$	kHz/50 ms
Initial carrier frequency tolerance				-25	25		$\leq \pm 100$	kHz

## 5 Detailed Description

### 5.1 Overview

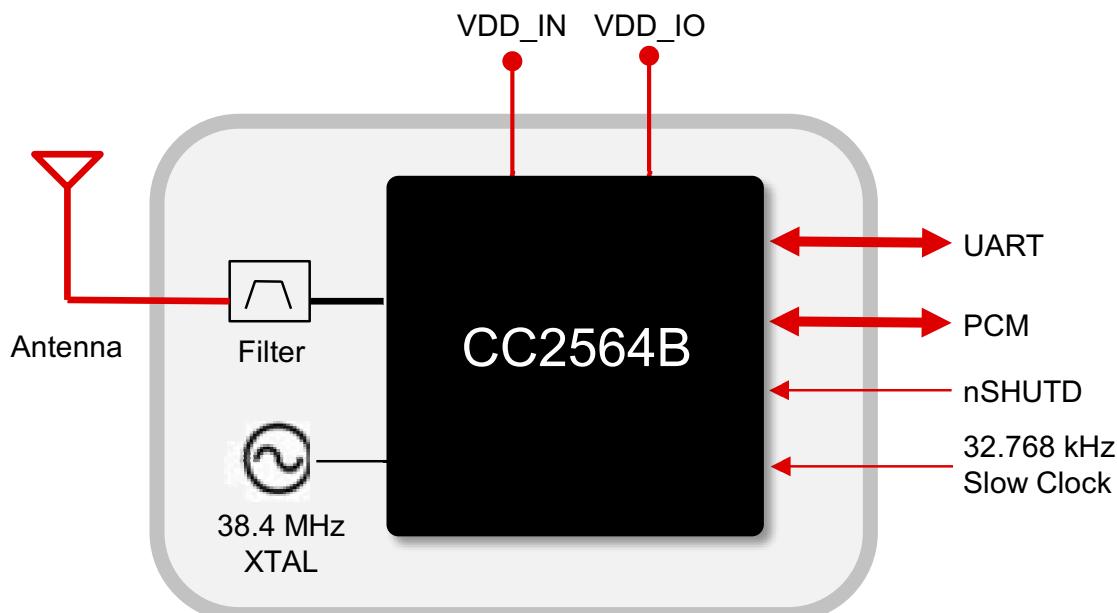
**Table 5-1. Technology and Assisted Modes Supported**

MODULE	DESCRIPTION	TECHNOLOGY SUPPORTED			ASSISTED MODES SUPPORTED <sup>(1)</sup>	
		BR/EDR	LE	ANT	HFP 1.6 (WBS)	A2DP
CC2564MODx <sup>(2)</sup>	Bluetooth 4.1 + BLE	√	√		√	√
	Bluetooth 4.1 + ANT	√		√	√	√

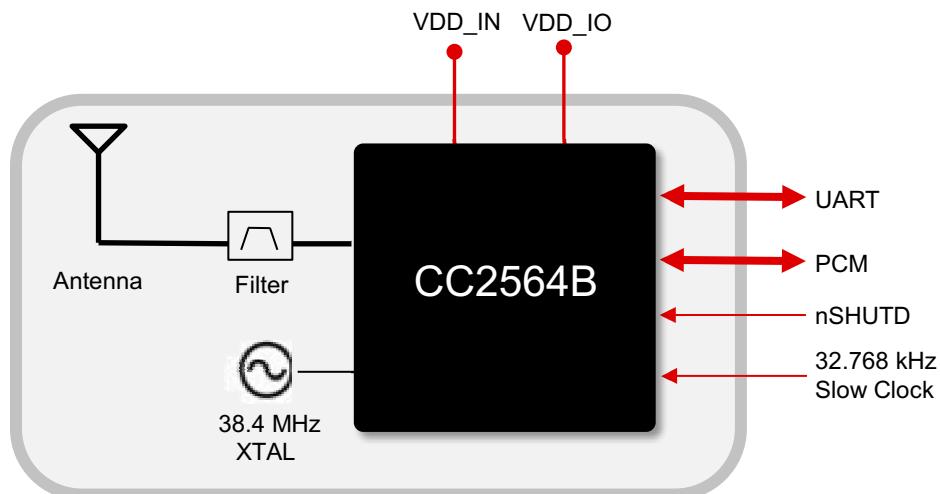
(1) The assisted modes (HFP 1.6 and A2DP) are not supported simultaneously. Furthermore, the assisted modes are not supported simultaneously with BLE or ANT.

(2) The device does not support simultaneous operation of LE and ANT.

### 5.2 Functional Block Diagram



**Figure 5-1. CC2564MODN Functional Block Diagram**



**Figure 5-2. CC2564MODA Functional Block Diagram**

### 5.3 Functional Blocks

The TI *Bluetooth* HCI module architecture comprises a DRP™ and a point-to-multipoint baseband core. The architecture is based on a single-processor ARM7TDMIE® core. The module includes several on-chip peripherals to enable easy communication with a host system and the *Bluetooth* BR/EDR/LE core.

### 5.4 Bluetooth BR/EDR Description

The CC2564MODx is *Bluetooth* 4.1 compliant up to the HCI level (for the technology supported, see [Table 5-1](#)):

- Up to seven active devices
- Scatternet: Up to 3 piconets simultaneously, 1 as master and 2 as slaves
- Up to two synchronous connection oriented (SCO) links on the same piconet
- Very fast AFH algorithm for asynchronous connection-oriented link (ACL) and extended SCO (eSCO) link
- Supports typically 10-dBm TX power without an external power amplifier (PA), thus improving *Bluetooth* link robustness
- Digital radio processor (DRP™) single-ended 50- $\Omega$  I/O for easy RF interfacing with external antenna (CC2564MODN). The CC2564MODA includes the antenna on the module.
- Internal temperature detection and compensation to ensure minimal variation in RF performance over temperature
- Includes a 128-bit hardware encryption accelerator as defined by the *Bluetooth* specifications
- Flexible pulse-code modulation (PCM) and inter-IC sound (I2S) digital codec interface:
  - Full flexibility of data format (linear, A-Law,  $\mu$ -Law)
  - Data width
  - Data order
  - Sampling
  - Slot positioning
  - Master and slave modes
  - High clock rates up to 15 MHz for slave mode (or 4.096 MHz for master mode)
- Support for all voice air-coding
  - CVSD
  - A-Law
  - $\mu$ -Law
  - Transparent (uncoded)

### 5.5 Bluetooth LE Description

- *Bluetooth* 4.1 compliant
- Solution optimized for proximity and sports use cases
- Multiple sniff instances that are tightly coupled to achieve minimum power consumption
- Independent buffering for LE, allowing large numbers of multiple connections without affecting BR/EDR performance.
- Includes built-in coexistence and prioritization handling for BR/EDR and LE

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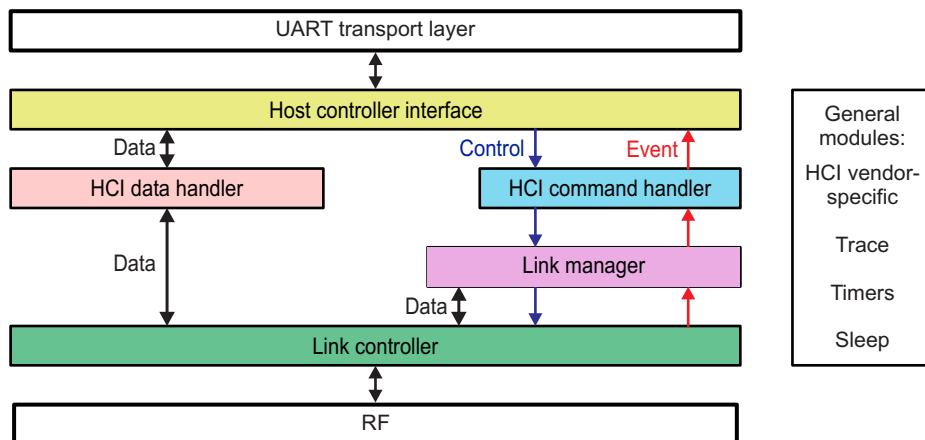
#### NOTE

ANT and the assisted modes (HFP 1.6 and A2DP) are not available when BLE is enabled.

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## 5.6 Bluetooth Transport Layers

Figure 5-3 shows the *Bluetooth* transport layers.



SWRS121-016

**Figure 5-3. Bluetooth Transport Layers**

## 5.7 Host Controller Interface

The TI *Bluetooth* HCI module incorporates one UART module dedicated to the HCI transport layer. The HCI interface transports commands, events, ACL between the device and the host using HCI data packets.

The maximum baud rate of the UART module is 4 Mbps; however, the default baud rate after power up is set to 115.2 kbps. The baud rate can thereafter be changed with a VS command. The device responds with a command complete event (still at 115.2 kbps), after which the baud rate change occurs.

The UART module includes the following features:

- Receiver detection of break, idle, framing, FIFO overflow, and parity error conditions
- Transmitter underflow detection
- CTS and RTS hardware flow control (UART Transport Layer)
- XON and XOFF software flow control (Three-wire UART Transport Layer)

Table 5-2 lists the UART module default settings.

**Table 5-2. UART Module Default Settings**

PARAMETER	VALUE
Bit rate	115.2 kbps
Data length	8 bits
Stop bit	1
Parity	None

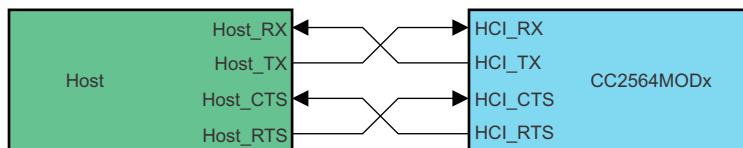
### 5.7.1 UART Transport Layer

The UART Transport Layer includes four signals:

- TX
- RX
- CTS
- RTS

Flow control between the host and the TI *Bluetooth* HCI module is bytewise by hardware.

Figure 5-4 shows UART Transport Layer.



**Figure 5-4. UART Transport Layer**

When the UART RX buffer of the TI *Bluetooth* HCI module passes the flow control threshold, it sets the *HCI\_RTS* signal high to stop transmission from the host.

When the *HCI\_CTS* signal is set high, the module stops transmission on the interface. If *HCI\_CTS* is set high while transmitting a byte, the module finishes transmitting the byte and stops the transmission.

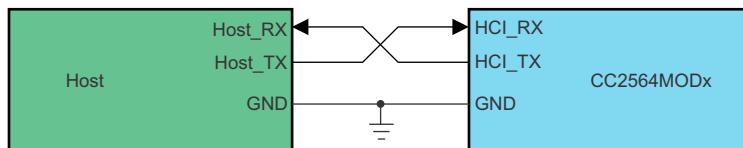
The UART Transport Layer includes a mechanism that handles the transition between active mode and sleep mode. The protocol occurs through the CTS and RTS UART lines and is known as the enhanced HCI low level (eHCILL) power-management protocol.

For more information on the UART Transport Layer, see *Volume 4 Host Controller Interface, Part A UART Transport Layer of the Bluetooth Core Specifications* ([www.bluetooth.org/en-us/specification/adoptedspecifications](http://www.bluetooth.org/en-us/specification/adoptedspecifications)).

### 5.7.2 Three-Wire UART Transport Layer

The Three-wire UART Transport Layer consists of three signals (see Figure 5-5):

- TX
- RX
- GND



**Figure 5-5. Three-Wire UART Transport Layer**

The Three-Wire UART Transport Layer supports the following features:

- Software flow control (XON/XOFF)
- Power management using the software messages:
  - WAKEUP
  - WOKEN
  - SLEEP
- CRC data integrity check

For more information on the Three-Wire UART Transport Layer, see *Volume 4 Host Controller Interface, Part D Three-Wire UART Transport Layer of the Bluetooth Core Specifications* ([www.bluetooth.org/en-us/specification/adoptedspecifications](http://www.bluetooth.org/en-us/specification/adoptedspecifications)).

## 5.8 Digital Codec Interface

The codec interface is a fully programmable port to support seamless interfacing with different PCM and I2S codec devices. The interface includes the following features:

- Two voice channels
- Master and slave modes
- All voice coding schemes defined by the *Bluetooth* specification: linear, A-Law, and  $\mu$ -Law

- Long and short frames
- Different data sizes, order, and positions
- High flexibility to support a variety of codecs
- Bus sharing: Data\_Out is in Hi-Z state when the interface is not transmitting voice data.

### 5.8.1 Hardware Interface

The interface includes four signals:

- Clock: configurable direction (input or output)
- Frame\_Sync and Word\_Sync: configurable direction (input or output)
- Data\_In: input
- Data\_Out: output or 3-state

The module can be the master of the interface when generating the Clock and Frame\_Sync signals or the slave when receiving these two signals.

For slave mode, clock input frequencies of up to 15 MHz are supported. At clock rates above 12 MHz, the maximum data burst size is 32 bits.

For master mode, the module can generate any clock frequency between 64 kHz and 4.096 MHz.

### 5.8.2 I2S

When the codec interface is configured to support the I2S protocol, these settings are recommended:

- Bidirectional, full-duplex interface
- Two time slots per frame: time slot-0 for the left channel audio data; and time slot-1 for the right channel audio data
- Each time slot is configurable up to 40 serial clock cycles long, and the frame is configurable up to 80 serial clock cycles long.

### 5.8.3 Data Format

The data format is fully configurable:

- The data length can be from 8 to 320 bits in 1-bit increments when working with 2 channels, or up to 640 bits when working with 1 channel. The data length can be set independently for each channel.
- The data position within a frame is also configurable within 1 clock (bit) resolution and can be set independently (relative to the edge of the Frame\_Sync signal) for each channel.
- The Data\_In and Data\_Out bit order can be configured independently. For example, Data\_In can start with the most significant bit (MSB); Data\_Out can start with the least significant bit (LSB). Each channel is separately configurable. The inverse bit order (that is, LSB first) is supported only for sample sizes up to 24 bits.
- Data\_In and Data\_Out are not required to be the same length.
- The Data\_Out line is configured to Hi-Z output between data words. Data\_Out can also be set for permanent Hi-Z, regardless of the data output. This configuration allows the module to be a bus slave in a multislave PCM environment. At power up, Data\_Out is configured as Hi-Z.

### 5.8.4 Frame Idle Period

The codec interface handles frame idle periods, in which the clock pauses and becomes 0 at the end of the frame, after all data are transferred.

The module supports frame idle periods both as master and slave of the codec bus.

When the module is the master of the interface, the frame idle period is configurable. There are two configurable parameters:

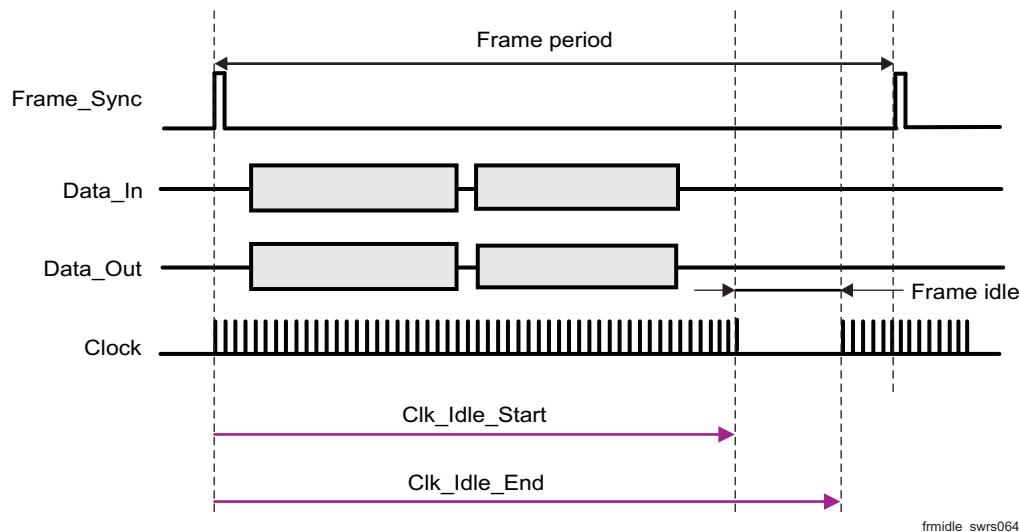
- Clk\_Idle\_Start: indicates the number of clock cycles from the beginning of the frame to the beginning of the idle period. After Clk\_Idle\_Start clock cycles, the clock becomes 0.
- Clk\_Idle\_End: indicates the time from the beginning of the frame to the end of the idle period. The time is given in multiples of clock periods.

The delta between Clk\_Idle\_Start and Clk\_Idle\_End is the clock idle period.

For example, for clock rate = 1 MHz, frame sync period = 10 kHz, Clk\_Idle\_Start = 60, Clk\_Idle\_End = 90.

Between both Frame\_Sync signals there are 70 clock cycles (instead of 100). The clock idle period starts 60 clock cycles after the beginning of the frame and lasts 90 – 60 = 30 clock cycles. Thus, the idle period ends 100 – 90 = 10 clock cycles before the end of the frame. The data transmission must end before the beginning of the idle period.

[Figure 5-6](#) shows the frame idle timing.

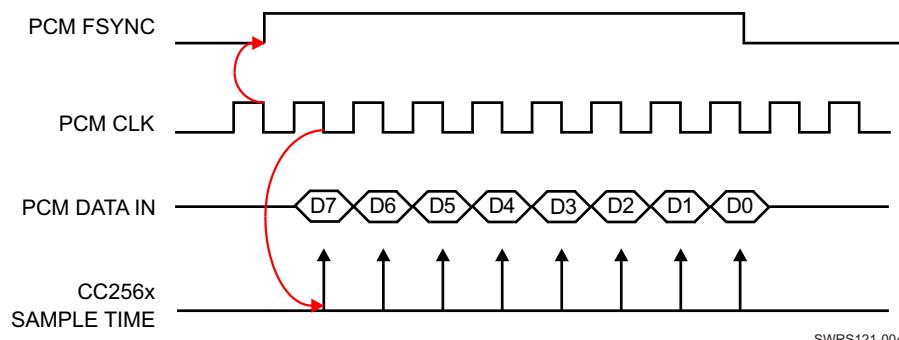


**Figure 5-6. Frame Idle Period**

### 5.8.5 Clock-Edge Operation

The codec interface of the module can work on the rising or the falling edge of the clock and can sample the Frame\_Sync signal and the data at inverted polarity.

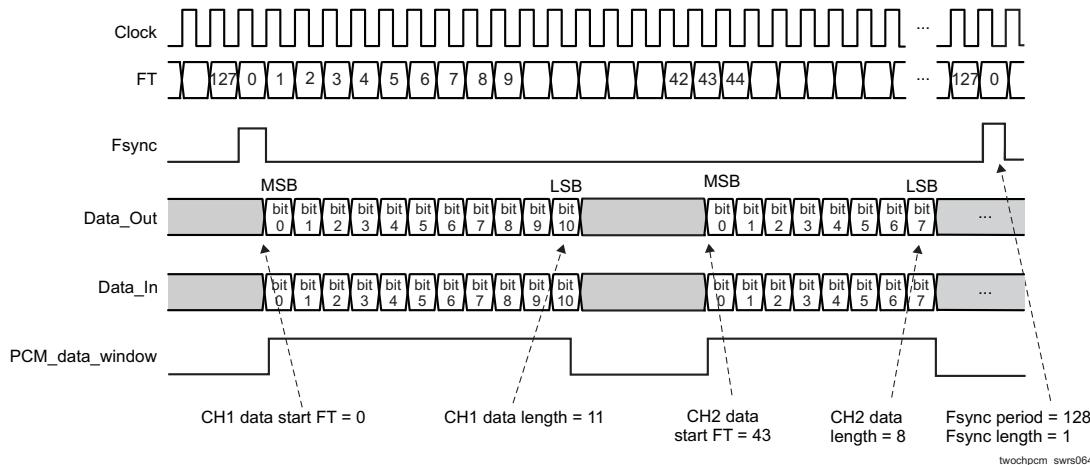
[Figure 5-7](#) shows the operation of a falling-edge-clock type of codec. The codec is the master of the bus. The Frame\_Sync signal is updated (by the codec) on the falling edge of the clock and is therefore sampled (by the module) on the next rising clock. The data from the codec is sampled (by the module) on the falling edge of the clock.



**Figure 5-7. Negative Clock Edge Operation**

### 5.8.6 Two-Channel Bus Example

Figure 5-8 shows a 2-channel bus in which the two channels have different word sizes and arbitrary positions in the bus frame. (FT stands for frame timer.)



**Figure 5-8. 2-Channel Bus Timing**

## 5.9 Assisted Modes

The TI CC2564MODx module contains an embedded coprocessor that can be used for multiple purposes. The module uses the coprocessor to perform the LE or ANT functionality. The module also uses the coprocessor to execute the assisted HFP 1.6 (WBS) or assisted A2DP functions. Only one of these functions can be executed at a time because they all use the same resources (that is, the coprocessor; see Table 5-1 for the modes of operation supported by the module).

This section describes the assisted HFP 1.6 (WBS) and assisted A2DP modes of operation in the module. These modes of operation minimize host processing and power by taking advantage of the device coprocessor to perform the voice and audio SBC processing required in HFP 1.6 (WBS) and A2DP profiles. This section also compares the architecture of the assisted modes with the common implementation of the HFP 1.6 and A2DP profiles.

The assisted HFP 1.6 (WBS) and assisted A2DP modes of operation comply fully with the HFP 1.6 and A2DP *Bluetooth* specifications. For more information on these profiles, see the corresponding *Bluetooth* profile specification in [Adopted Bluetooth Core Specifications](#).

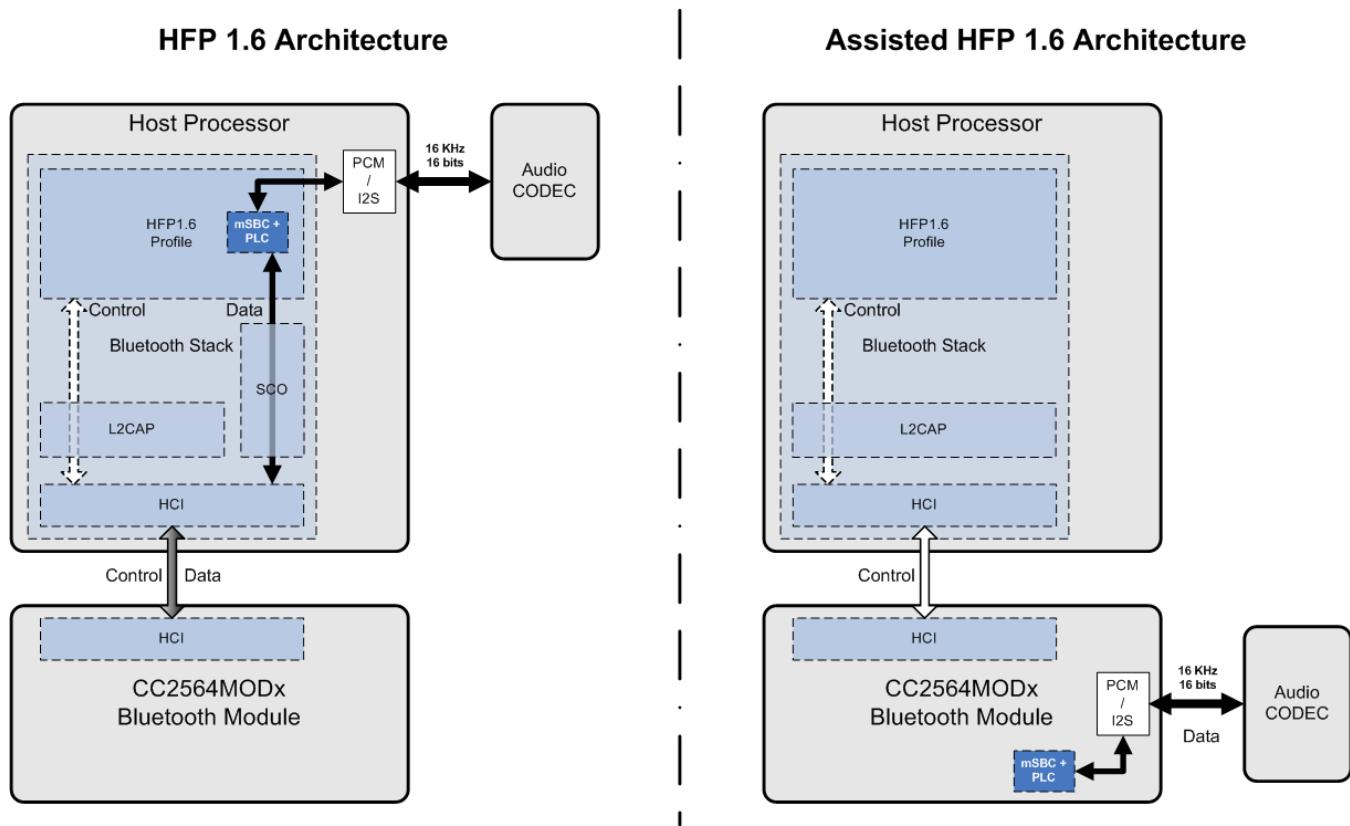
### 5.9.1 Assisted HFP 1.6 (WBS)

The HFP 1.6 Profile Specification adds the requirement for WBS support. The WBS feature allows twice the voice quality versus legacy voice coding schemes at the same air bandwidth (64 kbps). This feature is achieved using a voice sampling rate of 16 kHz, a modified subband coding (mSBC) scheme, and a packet loss concealment (PLC) algorithm. The mSBC scheme is a modified version of the mandatory audio coding scheme used in the A2DP profile with the parameters listed in Table 5-3.

**Table 5-3. mSBC Parameters**

PARAMETER	VALUE
Channel mode	Mono
Sampling rate	16 kHz
Allocation method	Loudness
Subbands	8
Block length	15
Bitpool	26

The assisted HFP 1.6 mode of operation implements this WBS feature on the embedded coprocessor. That is, the mSBC voice coding scheme and the PLC algorithm are executed in the coprocessor rather than in the host, thus minimizing host processing and power. One WBS connection at a time is supported and WBS and NBS connections cannot be used simultaneously in this mode of operation. [Figure 5-9](#) shows the architecture comparison between the common implementation of the HFP 1.6 profile and the assisted HFP 1.6 solution.



**Figure 5-9. HFP 1.6 Architecture Versus Assisted HFP 1.6 Architecture**

### 5.9.2 Assisted A2DP

The A2DP enables wireless transmission of high-quality mono or stereo audio between two devices. A2DP defines two roles:

- A2DP source is the transmitter of the audio stream.
- A2DP sink is the receiver of the audio stream.

A typical use case streams music from a tablet, phone, or PC (the A2DP source) to headphones or speakers (the A2DP sink). This section describes the architecture of these roles and compares them with the corresponding assisted-A2DP architecture. To use the air bandwidth efficiently, the audio data must be compressed in a proper format. The A2DP mandates support of the SBC scheme. Other audio coding algorithms can be used; however, both *Bluetooth* devices must support the same coding scheme. SBC is the only coding scheme spread out in all A2DP *Bluetooth* devices, and thus the only coding scheme supported in the assisted A2DP modes. [Table 5-4](#) lists the recommended parameters for the SBC scheme in the assisted A2DP modes.

**Table 5-4. Recommended Parameters for the SBC Scheme in Assisted A2DP Modes**

<b>SBC ENCODER SETTINGS<sup>(1)</sup></b>	<b>MID QUALITY</b>				<b>HIGH QUALITY</b>			
	<b>MONO</b>		<b>JOINT STEREO</b>		<b>MONO</b>		<b>JOINT STEREO</b>	
Sampling frequency (kHz)	44.1	48	44.1	48	44.1	48	44.1	48
Bitpool value	19	18	35	33	31	29	53	51
Resulting frame length (bytes)	46	44	83	79	70	66	119	115
Resulting bit rate (Kbps)	127	132	229	237	193	198	328	345

(1) Other settings: Block length = 16; allocation method = loudness; subbands = 8.

The SBC scheme supports a wide variety of configurations to adjust the audio quality. [Table 5-5](#) through [Table 5-12](#) list the supported SBC capabilities in the assisted A2DP modes.

**Table 5-5. Channel Modes**

<b>CHANNEL MODE</b>	<b>STATUS</b>
Mono	Supported
Stereo	Supported
Joint stereo	Supported
Dual channel	Supported

**Table 5-6. Sampling Frequency**

<b>SAMPLING FREQUENCY (kHz)</b>	<b>STATUS</b>
16	Supported
44.1	Supported
48	Supported

**Table 5-7. Block Length**

<b>BLOCK LENGTH</b>	<b>STATUS</b>
4	Supported
8	Supported
12	Supported
16	Supported

**Table 5-8. Subbands**

<b>SUBBANDS</b>	<b>STATUS</b>
4	Supported
8	Supported

**Table 5-9. Allocation Method**

<b>ALLOCATION METHOD</b>	<b>STATUS</b>
SNR	Supported
Loudness	Supported

**Table 5-10. Bitpool Values**

BITPOOL RANGE	STATUS
Assisted A2DP sink: 2–54	Supported
Assisted A2DP source: 2–57	Supported

**Table 5-11. L2CAP MTU Size**

L2CAP MTU SIZE (BYTES)	STATUS
Assisted A2DP sink: 260–800	Supported
Assisted A2DP source: 260–1021	Supported

**Table 5-12. Miscellaneous Parameters**

ITEM	VALUE	STATUS
A2DP content protection	Protected	Not supported
AVDTP service	Basic type	Supported
L2CAP mode	Basic mode	Supported
L2CAP flush	Nonflushable	Supported

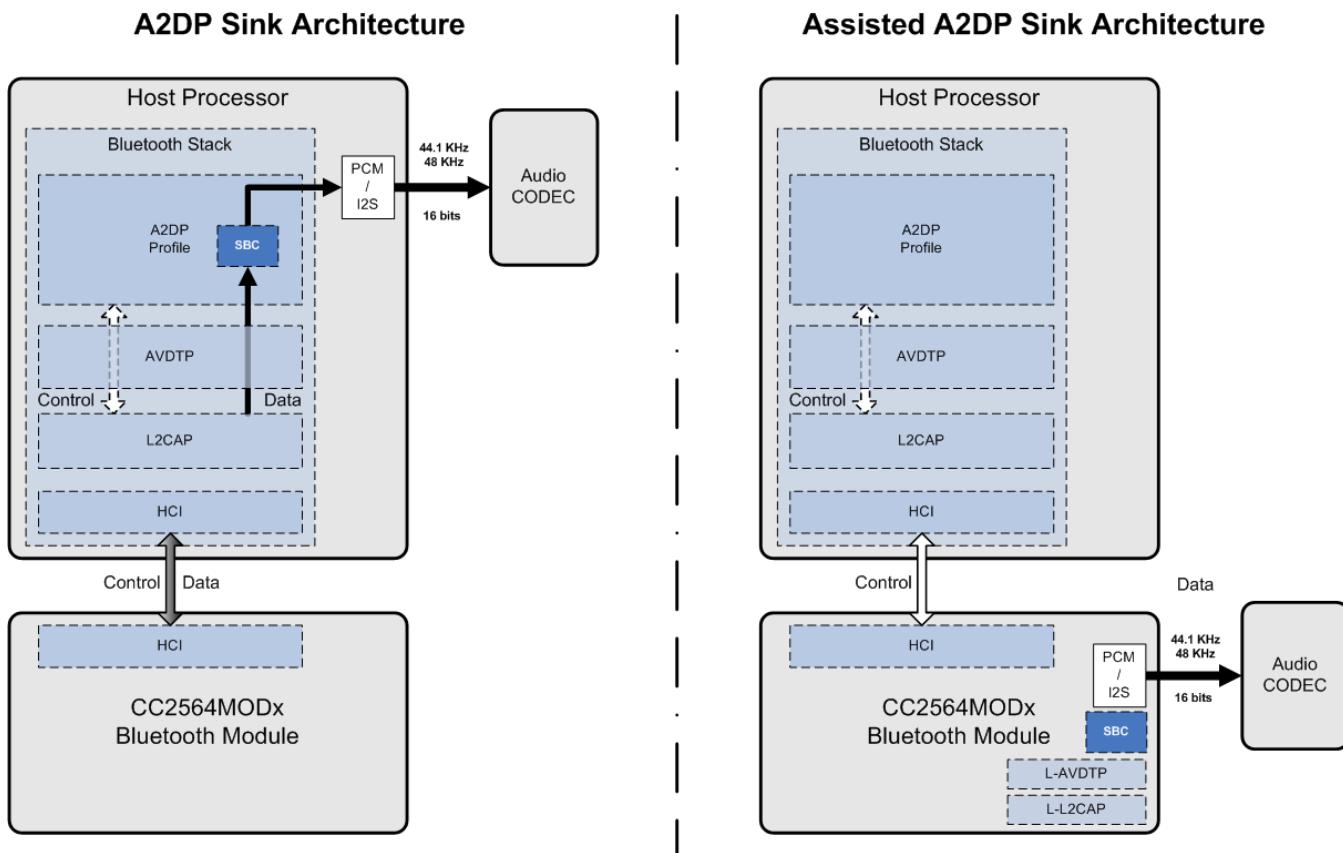
For detailed information on the A2DP profile, see the A2DP Profile Specification at [Adopted Bluetooth Core Specifications](#).

### 5.9.2.1 Assisted A2DP Sink

The A2DP sink role is the receiver of the audio stream in an A2DP *Bluetooth* connection. In this role, the A2DP layer and its underlying layers are responsible for link management and data decoding. To handle these tasks, two logic transports are defined:

- Control and signaling logic transport
- Data packet logic transport

The assisted A2DP takes advantage of this modularity to handle the data packet logic transport in the module by implementing a light L2CAP layer (L-L2CAP) and light AVDTP layer (L-AVDTP) to defragment the packets. Then the assisted A2DP performs the SBC decoding on-chip to deliver raw audio data through the module PCM–I2S interface. [Figure 5-10](#) shows the comparison between a common A2DP sink architecture and the assisted A2DP sink architecture.



**Figure 5-10. A2DP Sink Architecture Versus Assisted A2DP Sink Architecture**

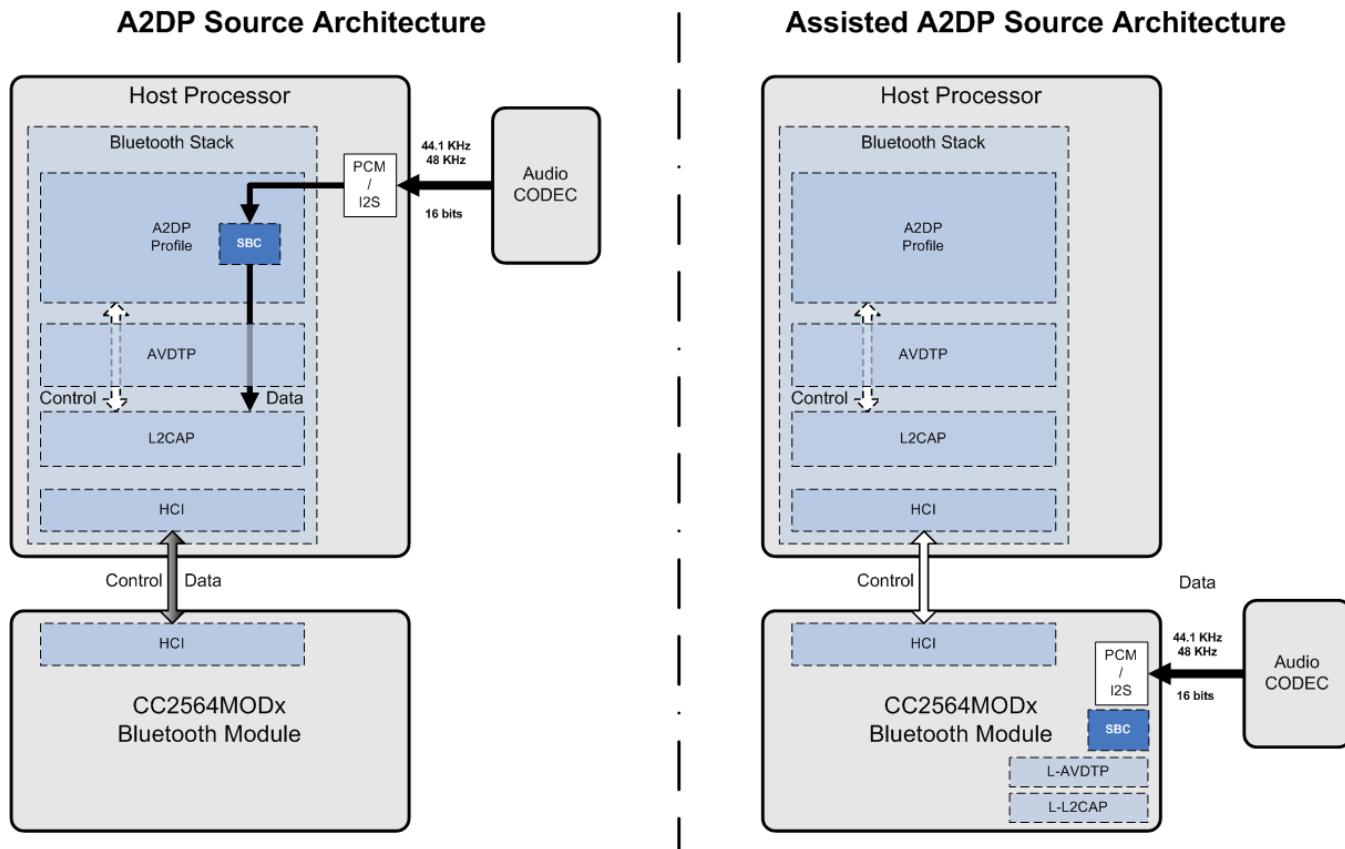
For more information on the A2DP sink role, see the A2DP Profile Specification at [Adopted Bluetooth Core Specifications](#).

### 5.9.2.2 Assisted A2DP Source

The role of the A2DP source is to transmit the audio stream in an A2DP *Bluetooth* connection. In this role, the A2DP layer and its underlying layers are responsible for link management and data encoding. To handle these tasks, two logic transports are defined:

- Control and signaling logic transport
- Data packet logic transport

The assisted A2DP takes advantage of this modularity to handle the data packet logic transport in the module. First, the assisted A2DP encodes the raw data from the module PCM–I2S interface using an on-chip SBC encoder. The assisted A2DP then implements an L-L2CAP layer and an L-AVDTP layer to fragment and packetize the encoded audio data. [Figure 5-11](#) shows the comparison between a common A2DP source architecture and the assisted A2DP source architecture.



**Figure 5-11. A2DP Source Architecture Versus Assisted A2DP Source Architecture**

For more information on the A2DP source role, see the A2DP Profile Specification at [Adopted Bluetooth Core Specifications](#).

## 6 Applications, Implementation, and Layout

Information in the following Applications section is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 6.1 Reference Design Schematics

Figure 6-1 shows the reference schematics for the CC2564MODN module.

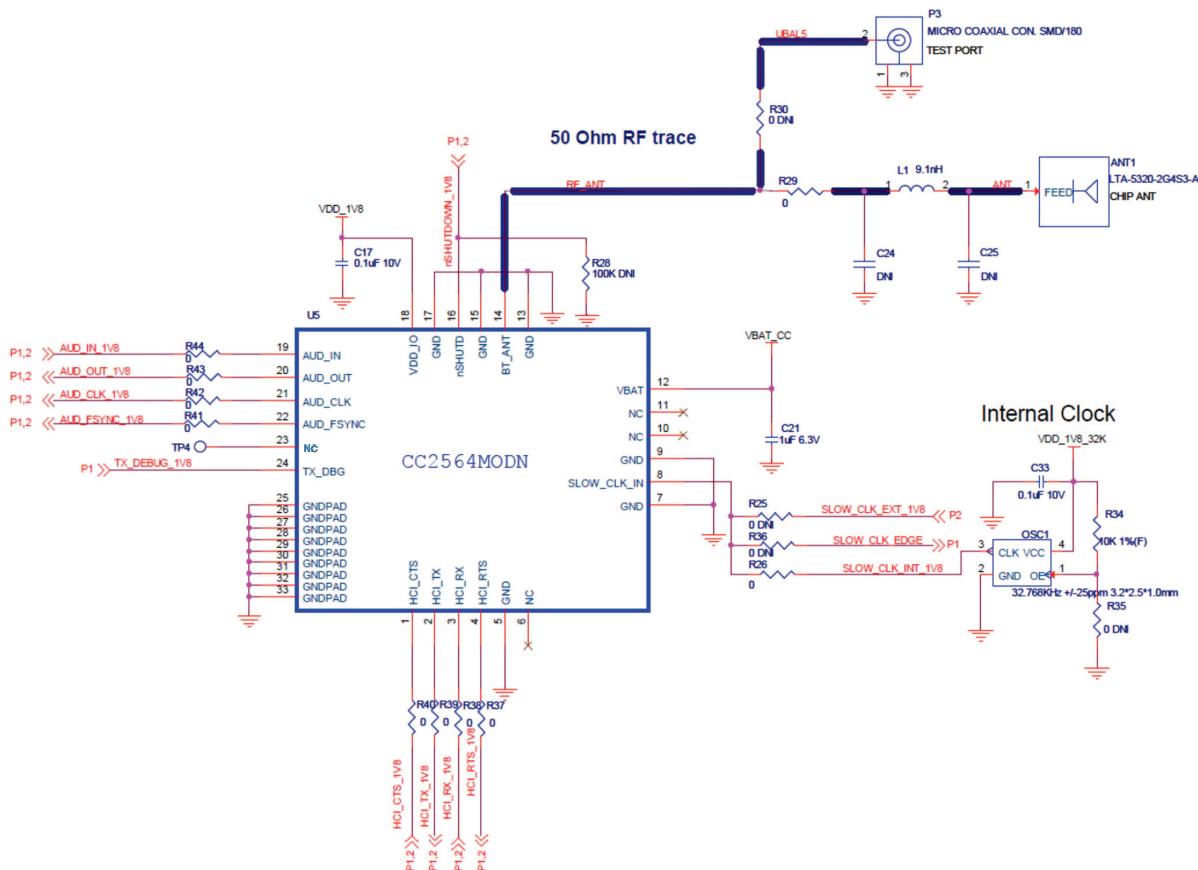
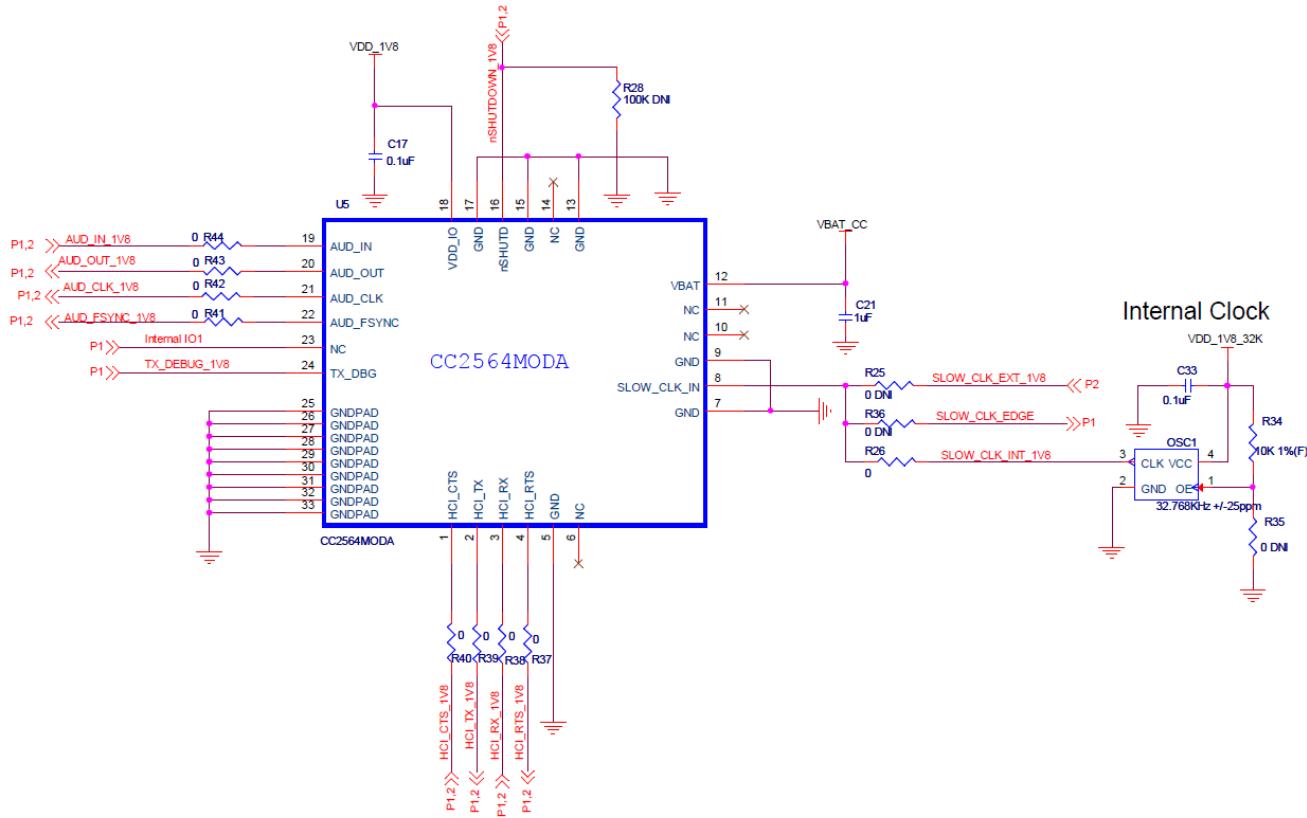


Figure 6-1. CC2564MODN Reference Schematics

Figure 6-2 shows the reference schematics for the CC2564MODA module.



**Figure 6-2. CC2564MODA Reference Schematics**

## 6.2 Layout

This section provides the printed circuit board (PCB) layout rules and considerations, including component placement and routing guidelines, when designing a board with the CC2564MODx module.

The integrator of the CC2564MODx module must comply with the PCB layout recommendations described in the following subsections to preserve the FCC and Industry Canada (IC) modular radio certification. Moreover, TI recommends customers follow the guidelines described in this section to achieve similar performance to that obtained with the TI reference design.

### 6.2.1 Layout Guidelines

#### 6.2.1.1 PCB Stack-Up

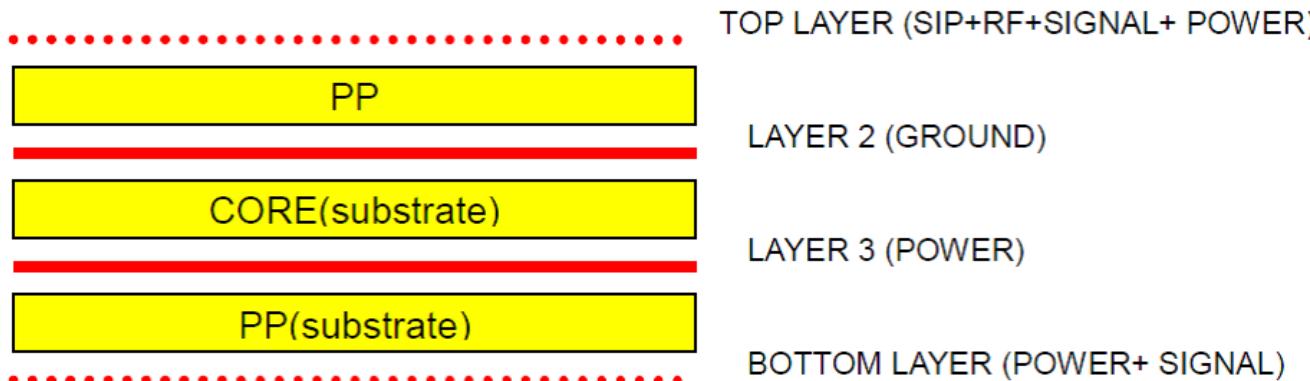
The recommended PCB stack-up is a four-layer design based on a standard flame-retardant 4 (FR4) material (see [Figure 6-3](#)):

**Layer 1 (TOP – RF + Signal)** Use layer 1 to place the module on and to route signal traces. In particular, the RF trace must be run on this layer.

**Layer 2 (L2 – Ground)** Layer 2 must be a solid ground layer.

**Layer 3 (L3 – Power)** Use layer 3 to route power traces or place power planes.

**Layer 4 (BOTTOM – Signal)** Use layer 4 as a second routable layer to run signal traces (except RF signals).



**Figure 6-3. PCB Stack-Up**

TI recommends a board thickness of 62.4 mils and a substrate dielectric of 4.2. For details, see [Table 6-1](#).

**NOTE**

These parameters are used for the  $50\Omega$  impedance matching of the RF trace. For more information, see [Section 6.2.1.2, RF Interface Guidelines](#).

**Table 6-1. Recommended PCB Properties**

ITEM	VALUE
Solder mask	0.4 mil
TOP copper + plating	1 oz/1.4 mil
PP (substrate)	10 mil
L2 copper + plating	1 oz/1.4 mil
Core (substrate)	36 mil
L3 copper + plating	1 oz/1.4 mil
PP (substrate)	10 mil
Bottom copper + plating	1 oz/1.4 mil
Solder mask	0.4 mil
Final thickness	62.4 mil = 1.585 mm

## 6.2.1.2 RF Interface Guidelines

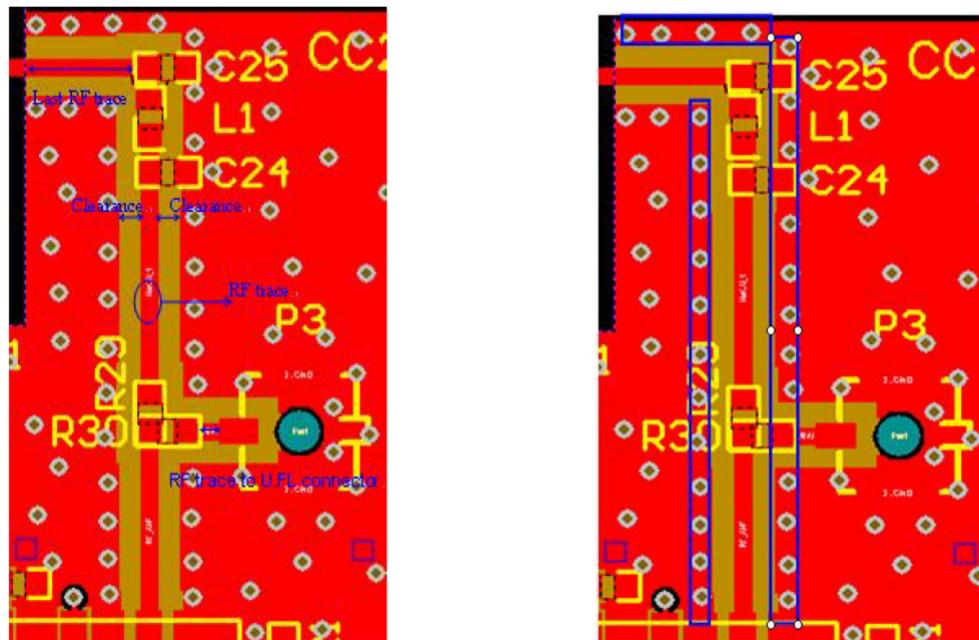
### 6.2.1.2.1 RF Trace (CC2564MODN Only)

Route the RF traces on layer 1 (top) and keep the routes as short as possible. These traces must be  $50\ \Omega$ , controlled-impedance traces with reference to the solid ground in the layer 2-microstrip transmission line. The TI reference design uses an RF trace width equal to 17 mils, which conforms to a  $50\ \Omega \pm 3\%$  simulated result, based on the following PCB properties: (see [Table 6-1](#) and [Figure 6-4](#)).

- Substrate height: 10 mils
- Substrate dielectric: 4.2
- Trace width: 17 mils
- Trace thickness: 1.4 mils
- Ground clearance: 20 mils

TI recommends the following guidelines for a good RF trace design:

- The RF traces must have via stitching on both ground planes around the RF trace (see [Figure 6-4](#)).
- Avoid placing clock signals close to the RF path.
- Place a u.FL connector (or similar) between the module and antenna if possible or during prototype phases (see [Figure 6-4](#).)
- The RF path should look like one single path along the RF traces and matching components. See [Figure 6-5](#) for the good (OK) case versus the not good (NG) case.
- The RF trace bends must be gradual with an approximate maximum bend of 45 degrees with trace mitered. RF traces must not have sharp corners. In addition:
  - Avoid case (1) in [Figure 6-6](#). A right angle leads to scattering and makes matching weak.
  - Case (2) in [Figure 6-6](#) is not recommended. Even if this bend had a good  $50\ \Omega$ , a careful simulation would be required.
  - Case (3) in [Figure 6-6](#) is recommended. The half-arc angle reduces scattering caused by a right angle.



**Figure 6-4. Placing a u.FL Connector Between the Module and Antenna**

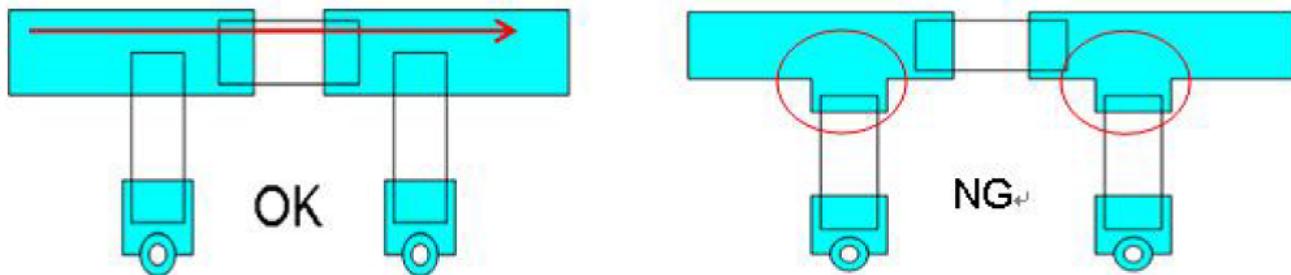


Figure 6-5. Good (OK) vs Not Good (NG) RF Path

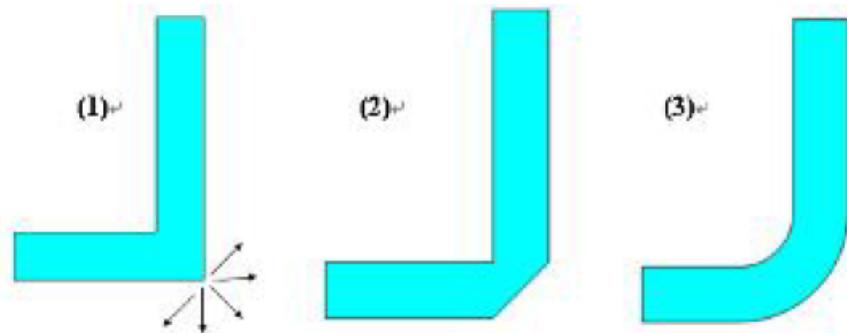


Figure 6-6. Not Recommended vs Recommended Trace Bends

### 6.2.1.3 Antenna

#### 6.2.1.3.1 CC2564MODN Antenna

The CC2564MODN module must be used with the approved external chip antenna (LTA-5320-2G4S3-A) and must comply with the following guidelines to preserve the modular radio certification (see [Figure 6-7](#)).

- Antenna clearance area = 15 mm × 8 mm
- Antenna solder termination to board edge length = 186 mils
- Antenna feed point to right side ground length = 140 mils
- Antenna feed point to last component trace = 244 mils
- Antenna pads to inside ground length = 208 mils
- An inductor L1 = 9.1 nH is required to properly match the chip antenna.

In addition, follow these general recommendations for a proper design with any antenna:

- Place the matching circuit as close as possible to the antenna feed point.
- Do not place traces or ground under the antenna section.
- Place the antenna, RF traces, and modules on the edge of the PCB product. In addition, consider the proximity of the antenna to the enclosure and consider the enclosure material.

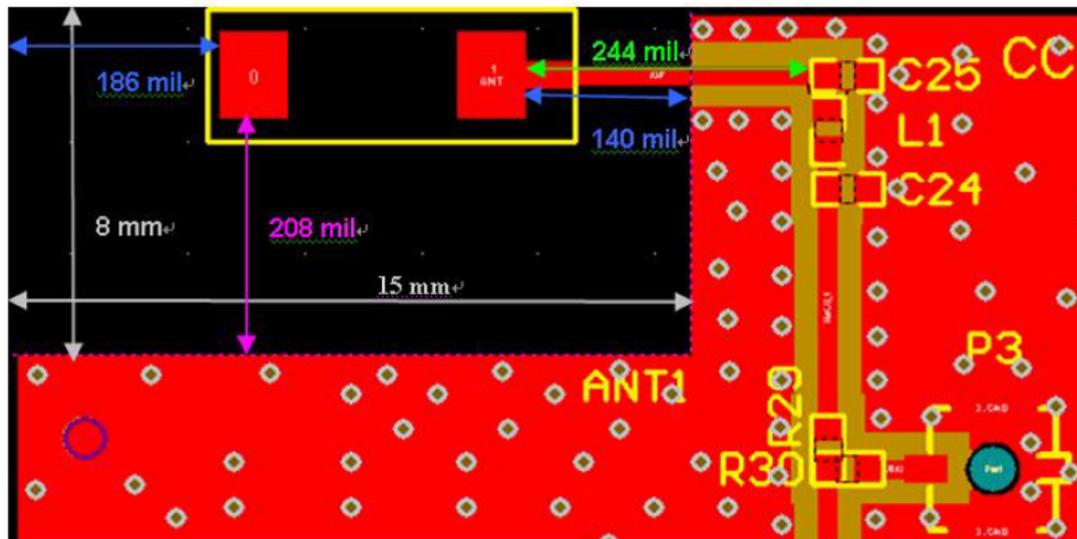


Figure 6-7. Antenna Guidelines

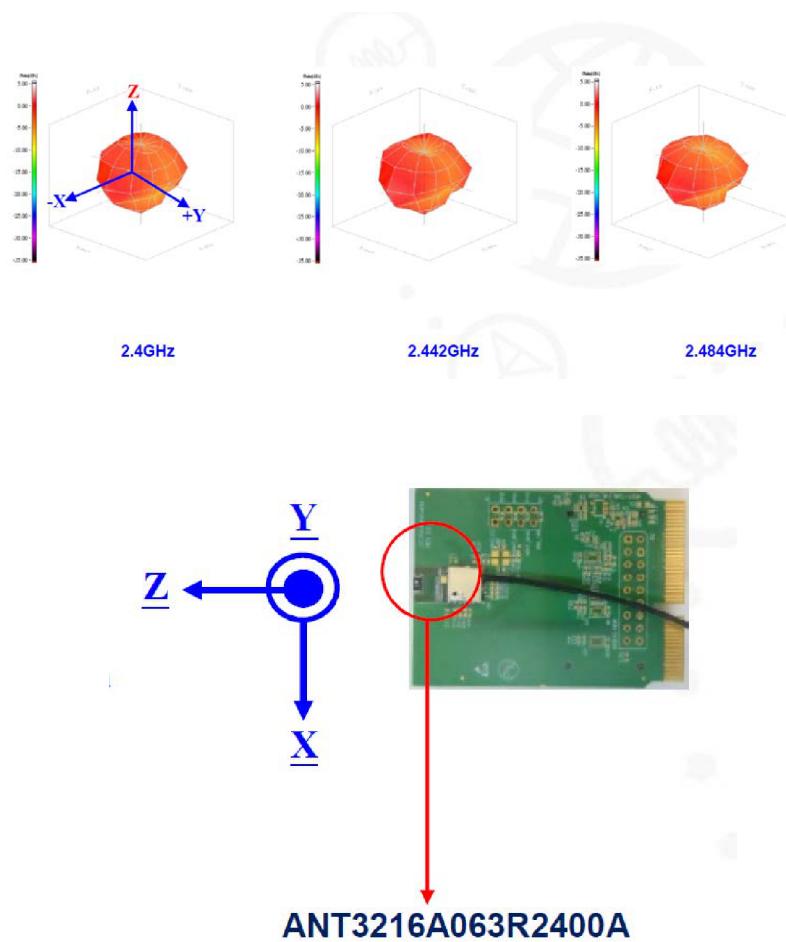
#### 6.2.1.3.2 CC2564MODA Antenna

The CC2564MODA module has an integrated chip antenna (ANT3216A063R2400A). [Table 6-2](#) lists antenna performance values in low, mid, and high frequencies of operation.

Table 6-2. Antenna Performance

ANTENNA	ANT3216A063R2400A			UNIT
Frequency	2.4	2.442	2.484	GHz
S11	-9.12	-15.19	-11.29	dB
Maximum gain	0.63	1.00	0.67	dBi
Average gain	-2.19	-1.90	-2.41	dBi
Efficiency	57.03%	64.01%	57.35%	

Figure 6-8 shows the 3-D radiation patterns.



**Figure 6-8. Antenna 3-D Radiation Patterns**

TI recommends applying the following guidelines for a proper design:

- Do not place traces or ground under and around the antenna section.
- Provide a clearance area of approximate 5.8 x 4.8 mm under the antenna area in all the PCB layers (see [Figure 6-9](#)).
- Place the module with the antenna area fitting on the edge of the PCB (see [Figure 6-9](#)).
- Follow the ground guidelines described in [Section 6.2.1.4, Power Supply and Ground Guidelines](#).
- In addition, consider the proximity of the antenna to the enclosure and consider the enclosure material.

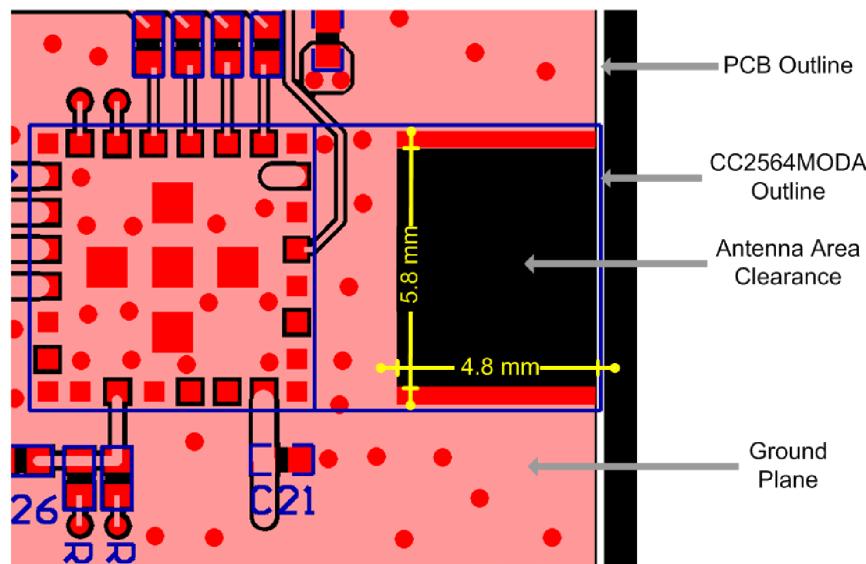


Figure 6-9. CC2564MODA Antenna layout

#### 6.2.1.4 Power Supply and Ground Guidelines

##### 6.2.1.4.1 Power Traces

TI recommends the following guidelines for the power supply of the CC2564MODx module:

- Use a star pattern format to supply power to the different pads of the module.
- Keep the power traces (VBAT and VIO) more than 14 mils.
- Use short power supply traces.
- Place decoupling capacitors as close as possible to the module (see [Figure 6-10](#)).

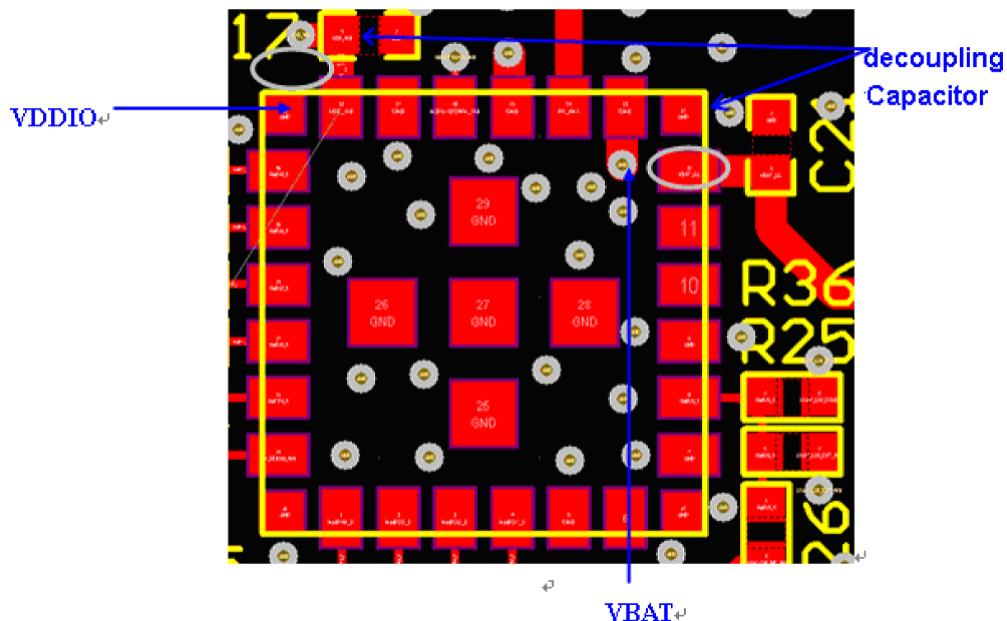
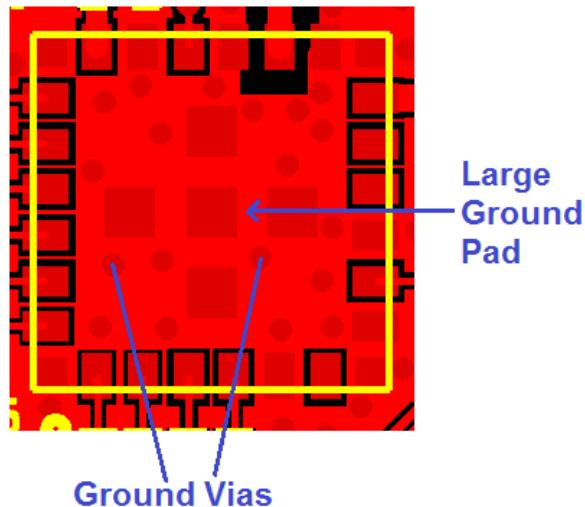


Figure 6-10. Placing Decoupling Capacitors as Close as Possible to the Module

#### 6.2.1.4.2 Ground

The common ground must be the solid ground plane in layer 2. TI recommends using a large ground pad under and around the module and placing enough ground vias beneath for a stable system and thermal dissipation (see [Figure 6-11](#)).



**Figure 6-11. Using a Large Ground Pad Under the Module**

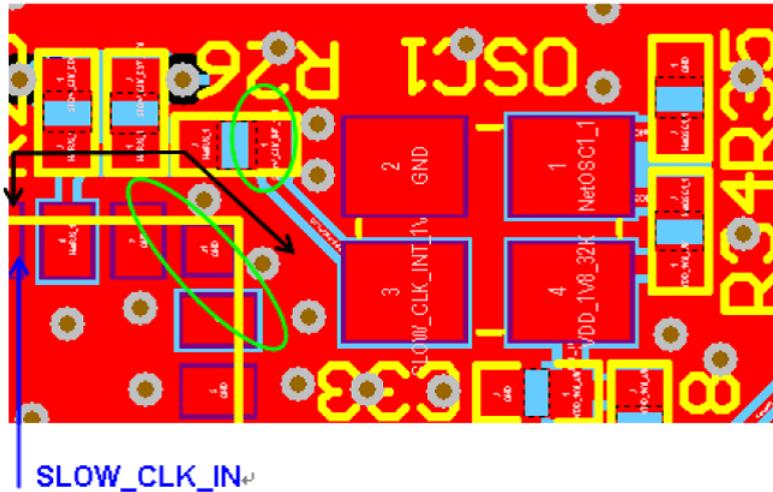
#### 6.2.1.5 Clock Guidelines

Remember that clock signal routing directly influences RF performance because of the signal trace susceptibility to noise.

##### 6.2.1.5.1 Slow Clock

TI recommends the following guidelines:

- Keep the slow clock signal lines as short as possible and at least 4-mils wide.
- Traces of slow clock signals must have a ground plane on each side of the signal trace to reduce undesired signal coupling.
- To reduce the capacitive coupling of undesired signals into the clock line, do not route slow clock traces above or below other signals (especially digital signals). [Figure 6-12](#) shows the slow clock trace in the TI reference design.



**Figure 6-12. Slow Clock Trace in TI Reference Design**

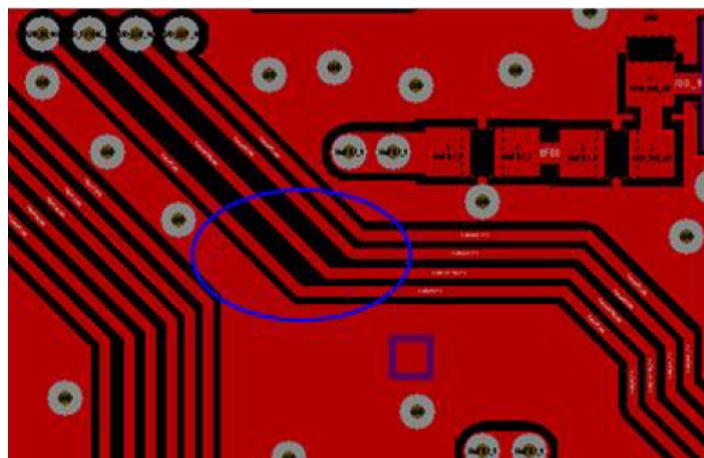
#### 6.2.1.6 Digital Interface Guidelines

##### 6.2.1.6.1 UART

The CC2564MODx UART default baud rate is 115.2 kbps but can run up to 4 Mbps. TI recommends separating these lines from the DC supply lines, RF lines, and sensitive clock lines and circuitry. To improve the return path and isolation, run the lines with ground on the adjacent layer when possible.

##### 6.2.1.6.2 PCM

The digital audio lines (pulse-code modulation [PCM]) are high-speed digital lines in which the four wires (AUD\_CLK, AUD\_FSYNC, AUD\_IN, and AUD\_OUT) must be roughly the same length. TI recommends running these lines as a bus interface (see [Figure 6-13](#)). These lines are high-speed digital and must be separated from DC supply lines, RF lines, and sensitive clock lines and circuitry. Run the lines with ground on the adjacent layer to improve the return path and isolation.



**Figure 6-13. Running the Digital Audio Lines**

## 6.2.2 Reference Design Drawings

### 6.2.2.1 CC2564MODN Reference Design

The dual-mode *Bluetooth* CC2564 module evaluation board (CC2564MODNEM) contains the CC2564MODN module and is intended for evaluation and design purposes (see Figure 6-14). For more information (such as schematics, BOM, and design files), see TI's [CC2564MODNEM tool folder](#).

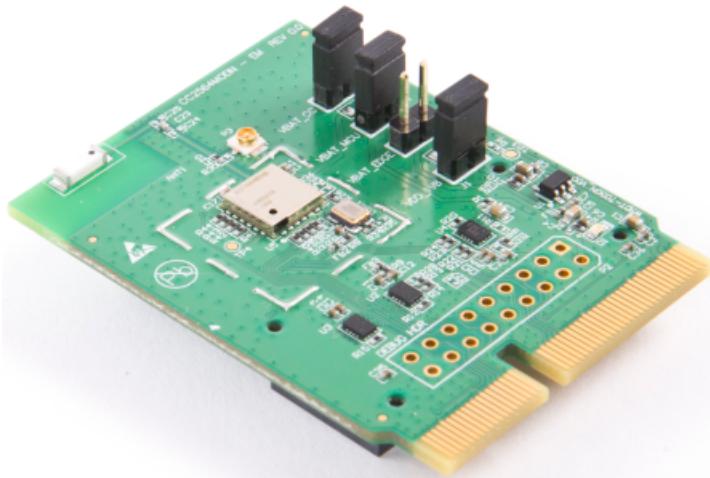


Figure 6-14. CC2564MODNEM Board

### 6.2.2.2 CC2564MODA Reference Design

The dual-mode *Bluetooth* CC2564 module with integrated antenna evaluation board (CC2564MODAEM) contains the CC2564MODA module and is intended for evaluation and design purposes (see Figure 6-15). For more information (such as schematics, BOM, and design files), see TI's [CC2564MODAEM tool folder](#).



Figure 6-15. CC2564MODAEM Board

## 6.3 Soldering Recommendations

Figure 6-16 shows the recommended reflow profile.

Referred to IPC/JEDEC standard.

Peak Temperature : <250°C

Number of Times : ≤2 times

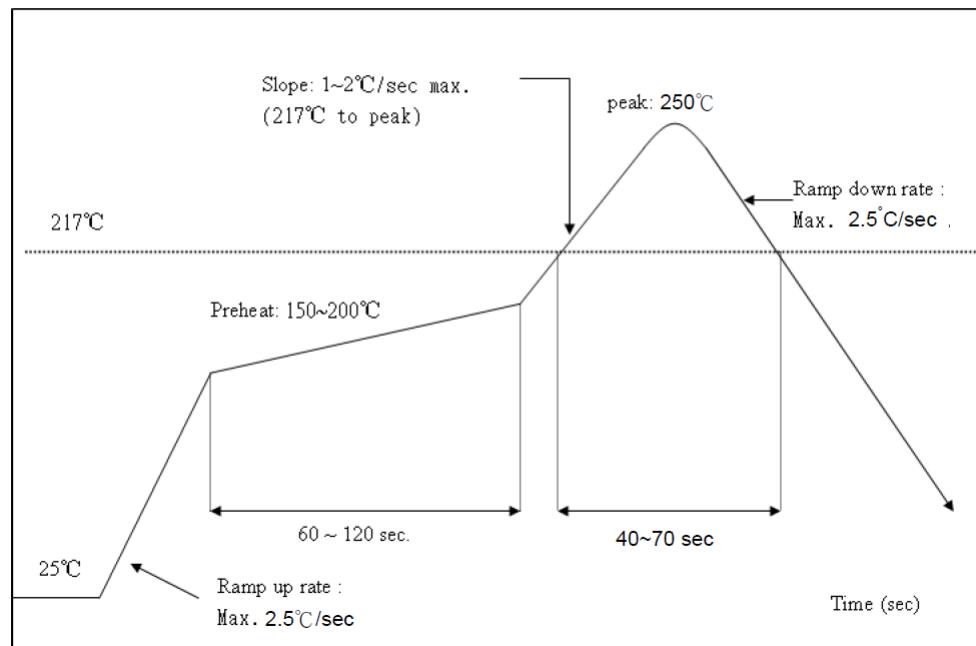


Figure 6-16. Reflow Profile

## 7 Device and Documentation Support

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### NOTE

Information in this section is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

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### 7.1 Device Certification and Qualification

The TI CC2564MODx module is certified for the FCC, IC, and ETSI/CE. Moreover, the module is a *Bluetooth Qualified Design* by the *Bluetooth Special Interest Group (Bluetooth SIG)*. TI Customers that build products based on the TI CC2564MODx module can save in testing cost and time per product family.

For more information, see the [CC256x Regulatory Compliance wiki](#) and the [CC256x Bluetooth SIG Certification wiki](#).

#### 7.1.1 FCC Certification

The TI CC2564MODx module is certified for the FCC as a single-modular transmitter. The module is a FCC-certified radio module that carries a modular grant. The module complies with the intentional radiator portion (Part 15c) of the FCC certification: Part 15.247 transmitter tests. For more information, see [CC2564MODx Modular Grant, FCC ID: Z64-2564N](#). A Class 2 Permissive Change is applied to CC2564MODA.

#### 7.1.2 IC Certification

The TI CC2564MODx module is certified for the IC as a single-modular transmitter. The TI CC2564MODx module meets IC modular approval and labeling requirements. The IC follows the same testing and rules as the FCC regarding certified modules in authorized equipment. For more information, see [CC2564MODx Modular Grant, IC ID: 451I-2564N](#). A Class 2 Permissive Change is applied to CC2564MODA.

#### 7.1.3 ETSI/CE Certification

The TI CC2564MODx module is CE certified with certifications to the appropriate EU radio and EMC directives summarized in the Declaration of Conformity and evidenced by the CE mark. The module is tested against the ETSI EN300-328 v1.8.1 radio tests, which is accepted by a number of countries for radio compliance. For more information, see [CC2564MODN DoC](#) and [CC2564MODA DoC](#).

#### 7.1.4 Bluetooth Special Interest Group Qualification

The TI CC2564MODx module is *Bluetooth* qualified and carries a Bluetooth 4.1 Controller Subsystem Qualification Design ID (QDID), which covers the lower layers of a *Bluetooth* design up to the HCI layer. TI customers that build products based on the TI CC2564MODx module can reference this QDID in their *Bluetooth* product Listing. For more information, see [CC2564MODN Controller Subsystem, QDID 55257](#) and [CC2564MODA Controller Subsystem, QDID 64631](#).

## 7.2 Device Support

### 7.2.1 Development Support

The following products support development of the CC2564MODx module:

- [TI Bluetooth Stack](#)
- [CC256x Bluetooth Hardware Evaluation Tool](#)

For a complete listing of development-support tools, see the TI [CC2564MODN product folder](#), [CC2564MODA product folder](#), and [CC256x wiki](#). For information on pricing and availability, contact the nearest TI field sales office or authorized distributor.

### **7.2.2 Device Nomenclature**

To designate the stages in the product development cycle, TI assigns prefixes to the part numbers. These prefixes represent evolutionary stages of product development from engineering prototypes through fully qualified production devices.

- X Experimental, preproduction, sample or prototype device. Device may not meet all product qualification conditions and may not fully comply with TI specifications. Experimental/Prototype devices are shipped against the following disclaimer: "This product is still in development and is intended for internal evaluation purposes." Notwithstanding any provision to the contrary, TI makes no warranty expressed, implied, or statutory, including any implied warranty of merchantability or fitness for a specific purpose, of this device.
- null Device is qualified and released to production. TI's standard warranty applies to production devices.

### **7.3 Documentation Support**

The following documents provide support for the CC2564MODx module.

CC2564MODAEM Design Files [SWRC317](#)

CC2564MODNEM Design Files [SWRA463](#)

### **7.4 Related Links**

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

**Table 7-1. Related Links**

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
CC2564MODN	<a href="#">Click here</a>				
CC2564MODA	<a href="#">Click here</a>				

### **7.5 Community Resources**

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

**TI E2E™ Online Community** *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At [e2e.ti.com](http://e2e.ti.com), you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**TI Embedded Processors Wiki** *Texas Instruments Embedded Processors Wiki.* Established to help developers get started with Embedded Processors from Texas Instruments and to foster innovation and growth of general knowledge about the hardware and software surrounding these devices.

### **7.6 Trademarks**

MSP430, DRP, E2E are trademarks of Texas Instruments.

Cortex, ARM7TDMI are registered trademarks of ARM Limited.

ARM is a registered trademark of ARM Physical IP, Inc.

iPod is a registered trademark of Apple, Inc.

Bluetooth is a registered trademark of Bluetooth SIG, Inc.

## 7.7 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.



ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

## 7.8 Glossary

**TI Glossary** This glossary lists and explains terms, acronyms, and definitions.

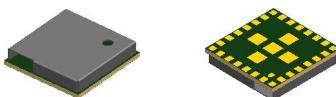
## 8 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

### 8.1 Mechanical Data

### 8.1.1 CC2564MODN Mechanical Data

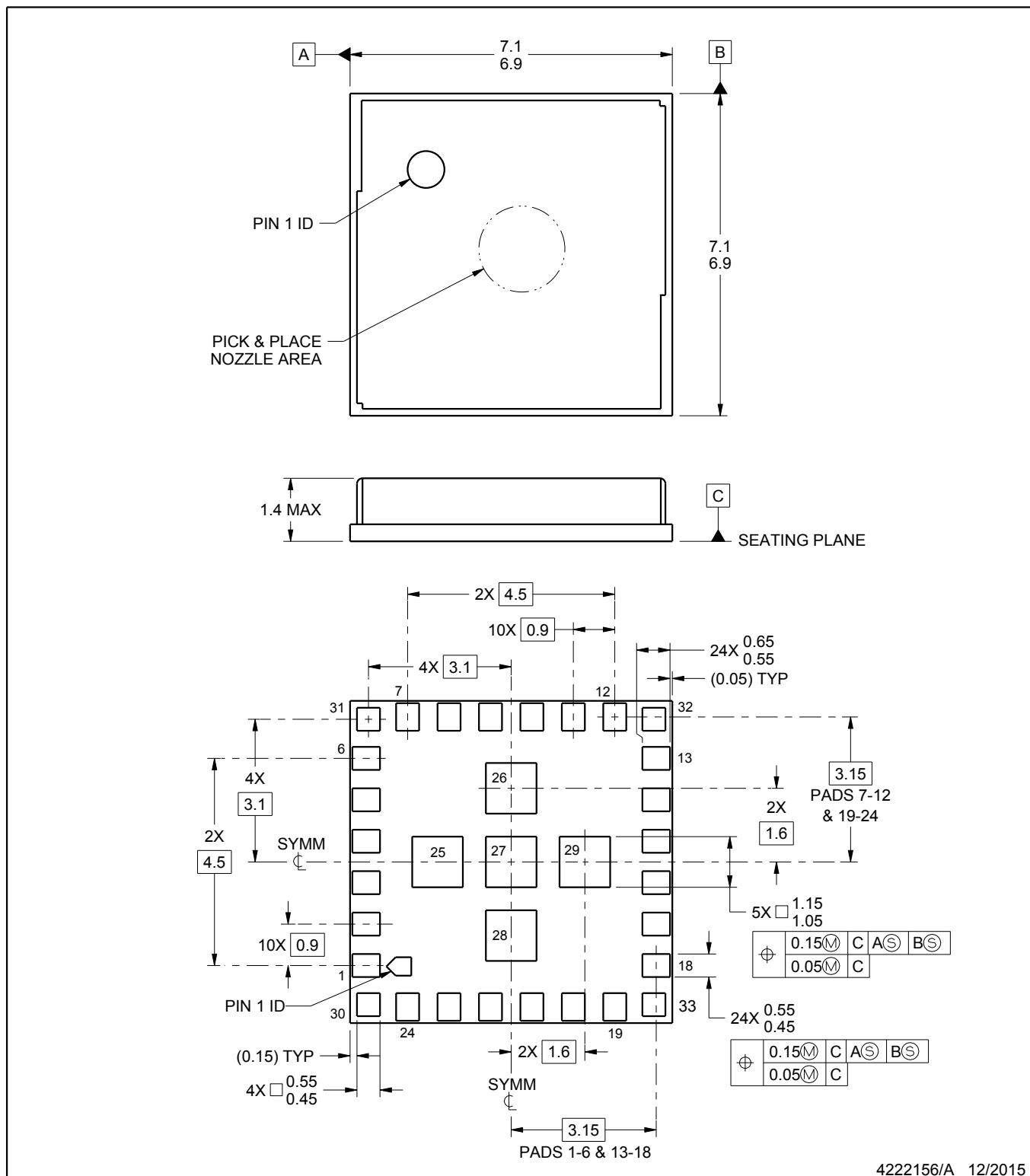
**MOE0033A**



## PACKAGE OUTLINE

**QFM - 1.4 mm max height**

QUAD FLAT MODULE



4222156/A 12/2015

**NOTES:**

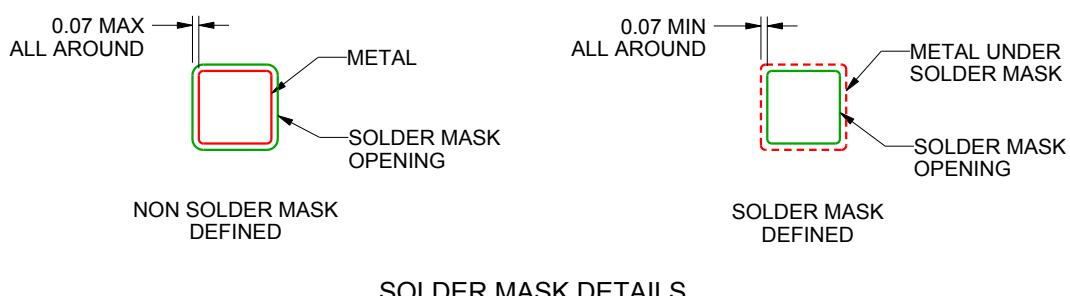
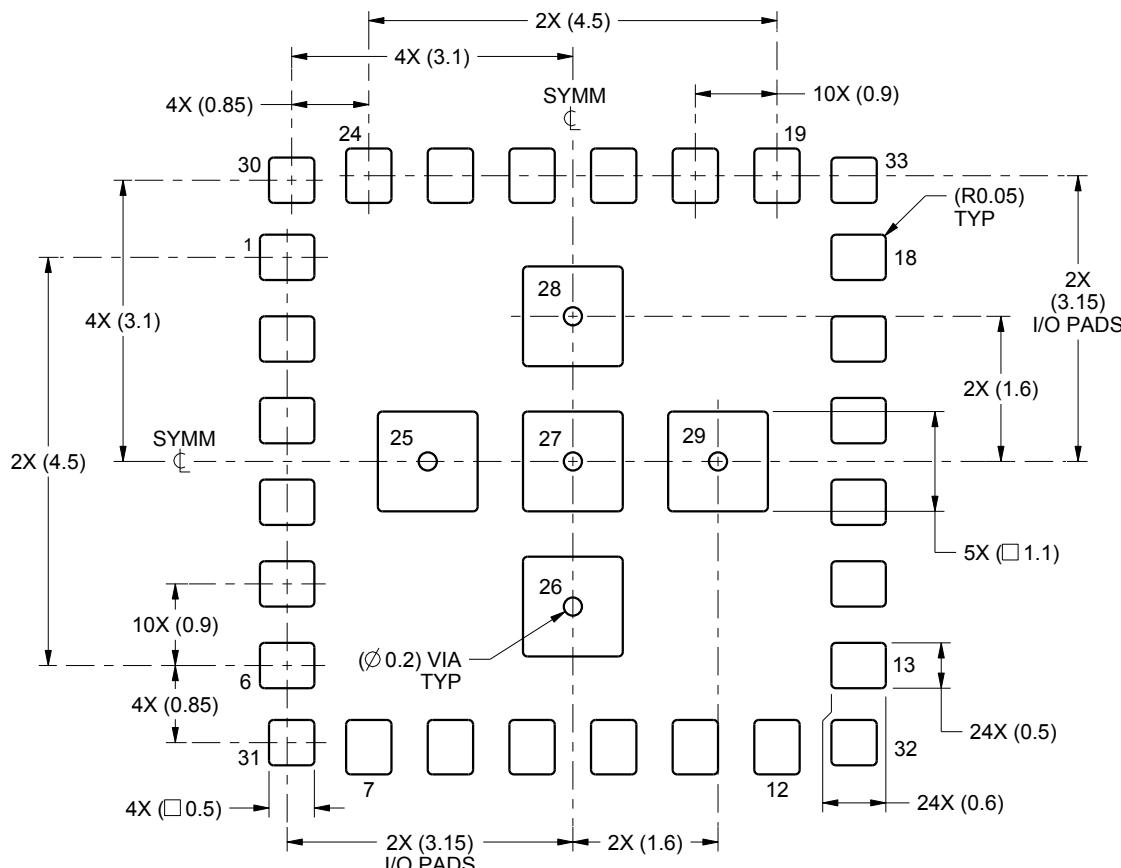
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.

# EXAMPLE BOARD LAYOUT

MOE0033A

QFM - 1.4 mm max height

QUAD FLAT MODULE



SOLDER MASK DETAILS

4222156/A 12/2015

NOTES: (continued)

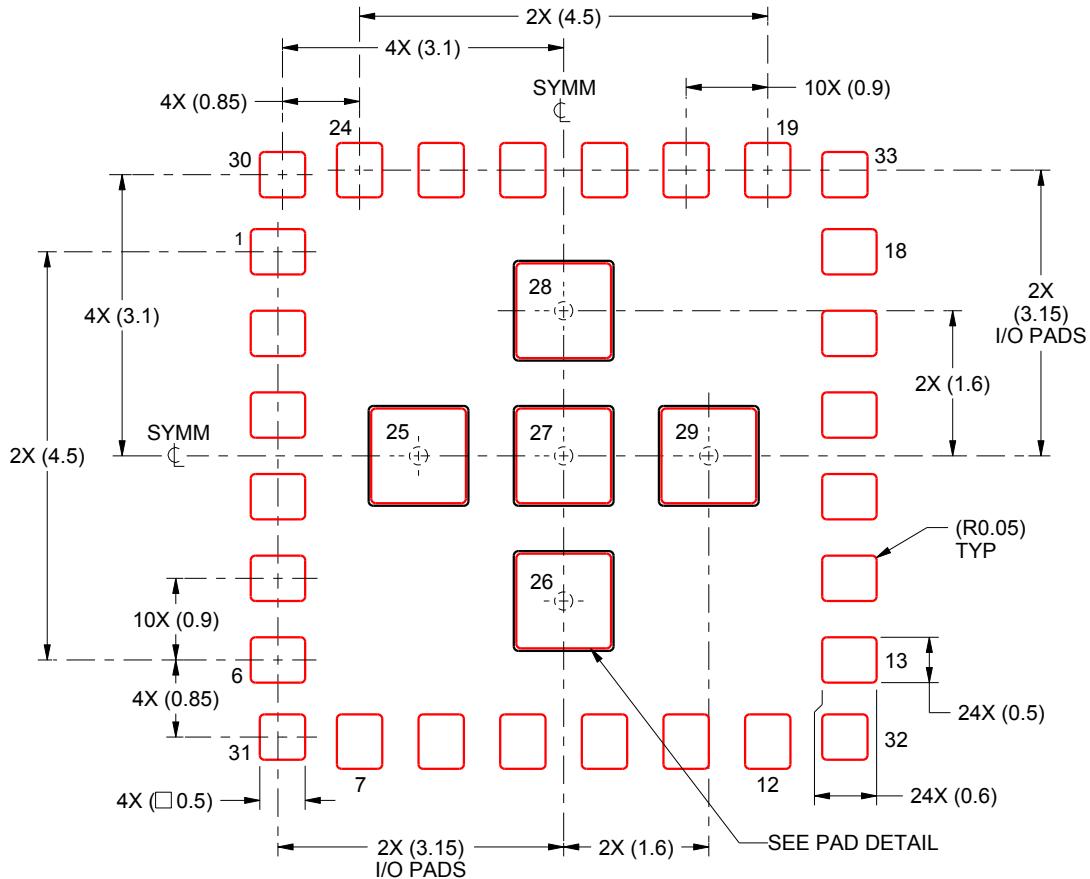
3. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/slua271](http://www.ti.com/lit/slua271)).

# EXAMPLE STENCIL DESIGN

MOE0033A

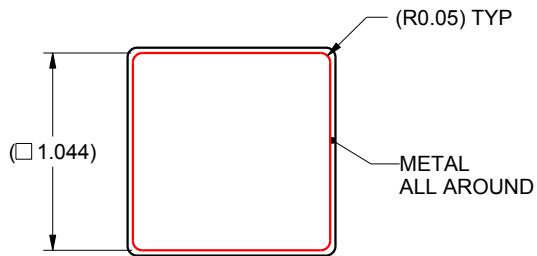
QFM - 1.4 mm max height

QUAD FLAT MODULE



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL

PRINTED SOLDER COVERAGE BY AREA  
PADS 25-29: 90%  
SCALE:12X



CENTER PAD DETAIL  
5X, SCALE:25X

4222156/A 12/2015

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

### 8.1.2 CC2564MODA Mechanical Data

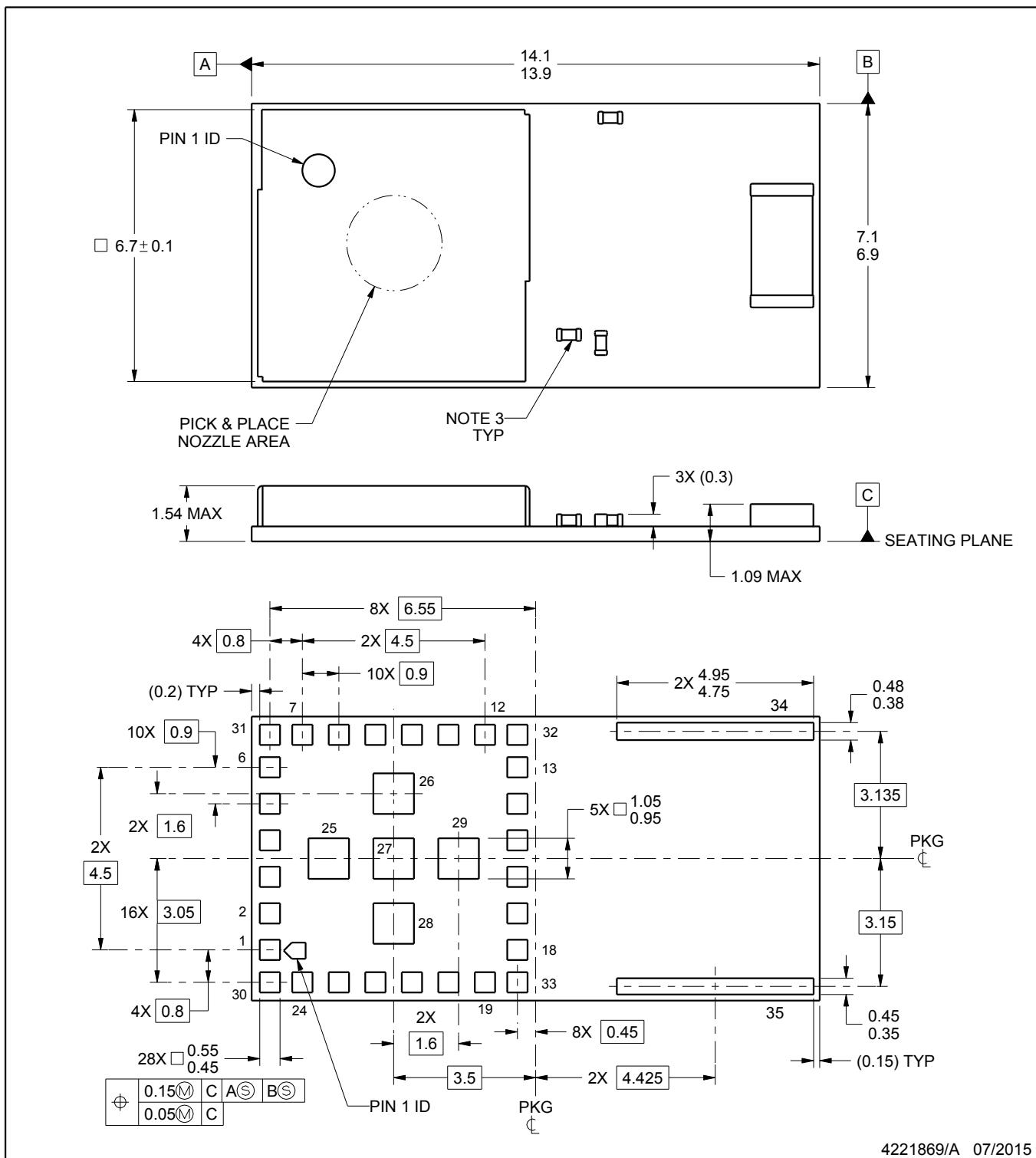
# PACKAGE OUTLINE

**MOG0035A**



**QFM - 1.54 mm max height**

QUAD FLAT MODULE



4221869/A 07/2015

**NOTES:**

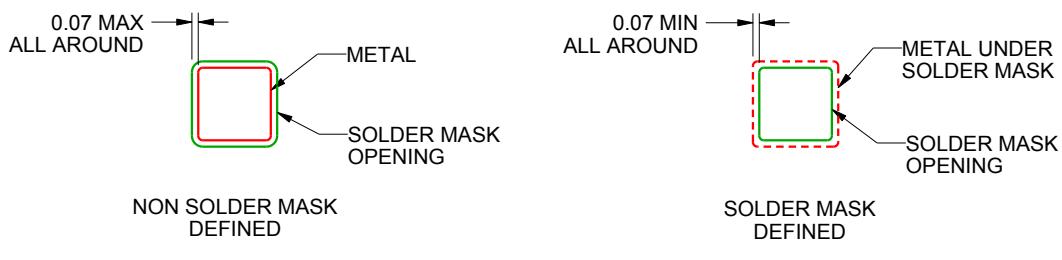
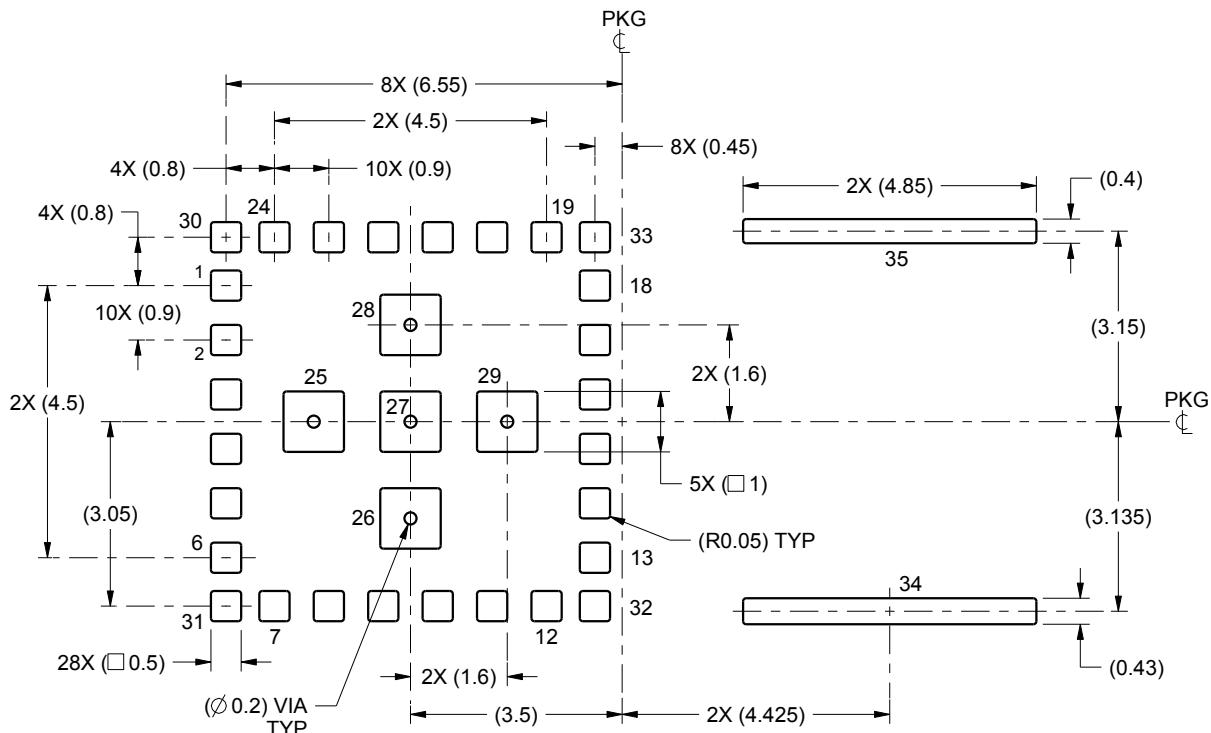
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Location, size and quantity of components are for reference only and could vary.

# EXAMPLE BOARD LAYOUT

MOG0035A

QFM - 1.54 mm max height

QUAD FLAT MODULE



4221869/A 07/2015

NOTES: (continued)

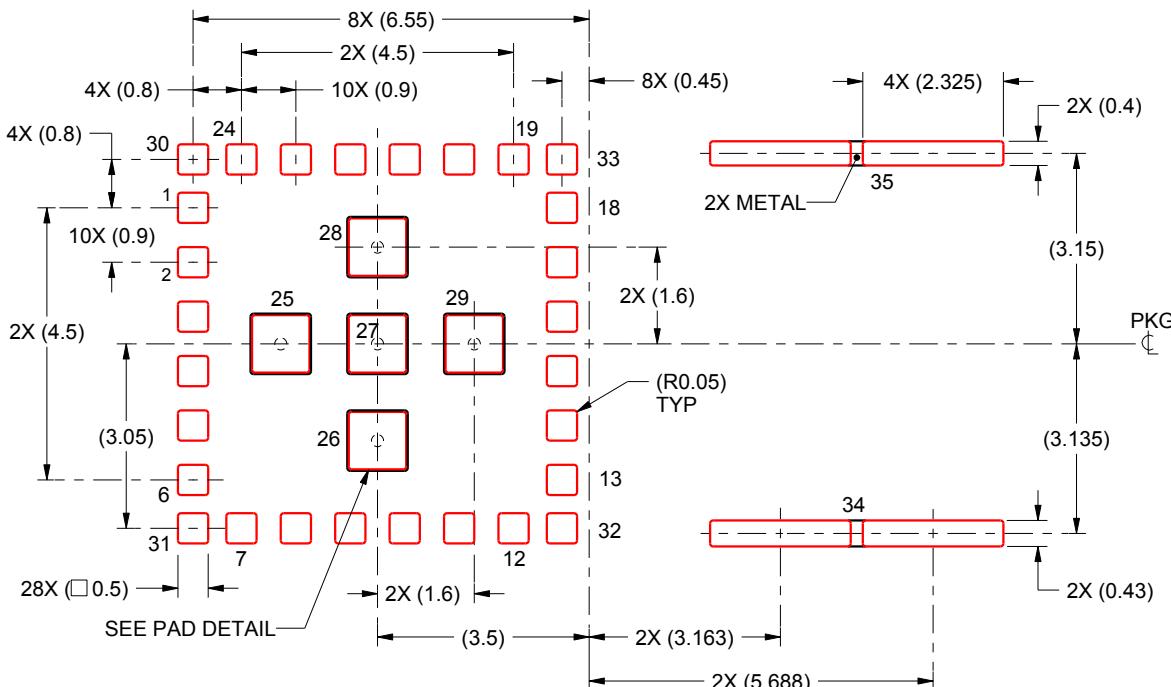
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/slua271](http://www.ti.com/lit/slua271)).

# EXAMPLE STENCIL DESIGN

MOG0035A

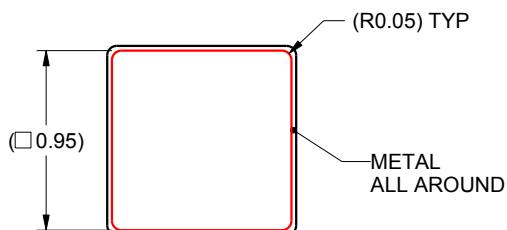
QFM - 1.54 mm max height

QUAD FLAT MODULE



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL

PADS 25-29: 90% PRINTED SOLDER COVERAGE BY AREA  
PADS 34 & 35: 96% PRINTED SOLDER COVERAGE BY AREA  
SCALE:8X



PAD DETAIL  
4X, SCALE:25X

4221869/A 07/2015

NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

## 8.2 Packaging and Ordering

### 8.2.1 Package and Ordering Information

Table 8-1. Package and Ordering Information

PART NUMBER <sup>(1)</sup>	STATUS	PACKAGE TYPE	MINIMUM ORDERABLE QUANTITY
CC2564MODNCMOET	Active	MOE	250
CC2564MODNCMOER	Active	MOE	2000
CC2564MODACMOG	Active	MOG	250

(1) Part number marking key:

- CC2564MODx – module variant (N: external antenna; A: integrated antenna)
- C – module marking (commercial)
- MOx – module package type: MOE (33 pins); MOG (35 pins)
- x – packaging designator (R: large T&R; T: small T&R; blank: tray)

Figure 8-1 shows the markings for the CC2564MODN module.

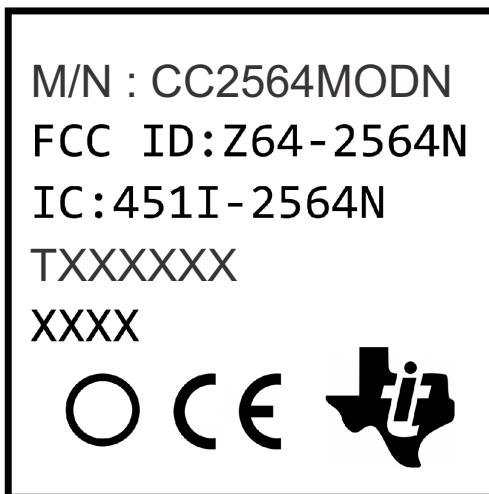
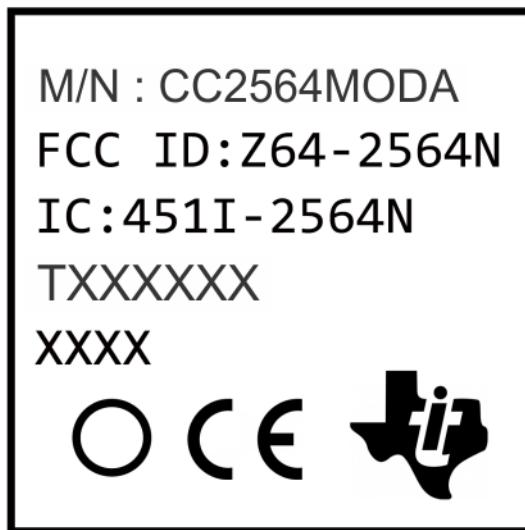


Figure 8-1. CC2564MODN Markings

Figure 8-2 shows the markings for the CC2564MODA module.



**Figure 8-2. CC2564MODA Markings**

Table 8-2 describes the CC2564MODx markings.

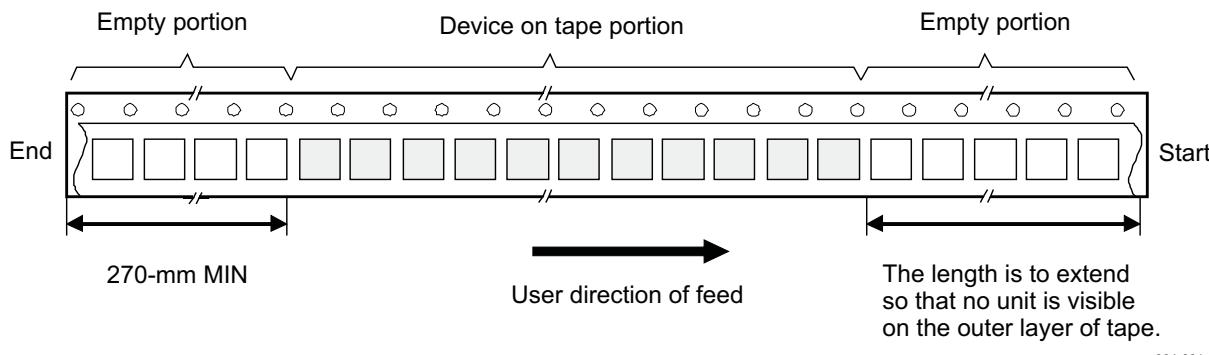
**Table 8-2. CC2564MODx Markings**

MARKING	DESCRIPTION
CC2564MODx	Model number <ul style="list-style-type: none"> <li>CC2564MODN: external antenna</li> <li>CC2564MODA: integrated antenna</li> </ul>
Z64 - 2564N	FCC ID: single modular FCC grant ID
451I - 2564N	IC: single modular IC grant ID
TXXXXXX	Lot order code (for example, A0A7123): <ul style="list-style-type: none"> <li>T = fixed</li> <li>Second and third digits = year code by hex (for example, 0A = 2010)</li> <li>Fourth digit = month code by hex (for example, 7 = July)</li> <li>Fifth to seventh digit = serial number by hex (for example, 123)</li> </ul>
XXXX	Production date code (for example, 1424): <ul style="list-style-type: none"> <li>XX = year (for example, 14 = 2014)</li> <li>XX = week (for example, 24 = week 24)</li> </ul>
CE	CE compliance mark

## 8.2.2 Tape and Reel Packaging Information (CC2564MODN Only)

### 8.2.2.1 Empty Tape Portion

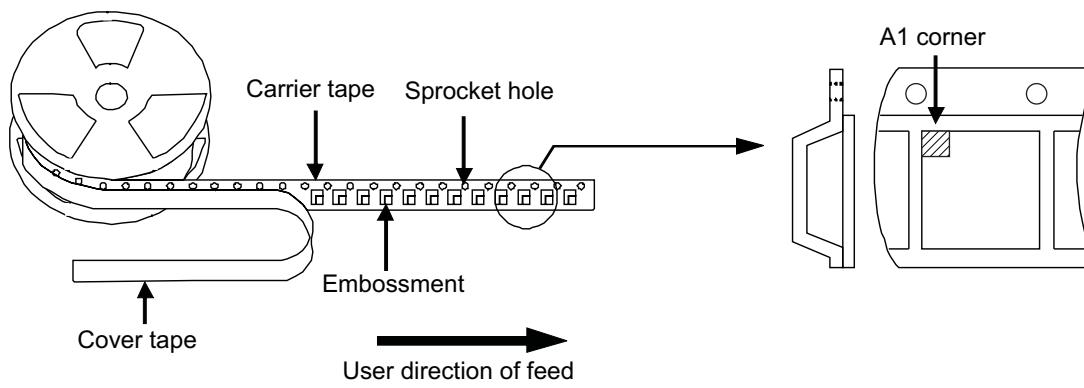
Figure 8-3 shows the empty portion of the carrier tape.



**Figure 8-3. Carrier Tape and Pockets**

### 8.2.2.2 Device Quantity and Direction

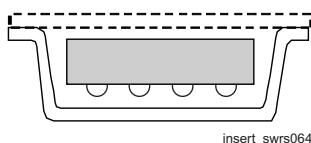
When pulling out the tape, the A1 corner is on the left side (see Figure 8-4).



**Figure 8-4. Direction of Device**

### 8.2.2.3 Insertion of Device

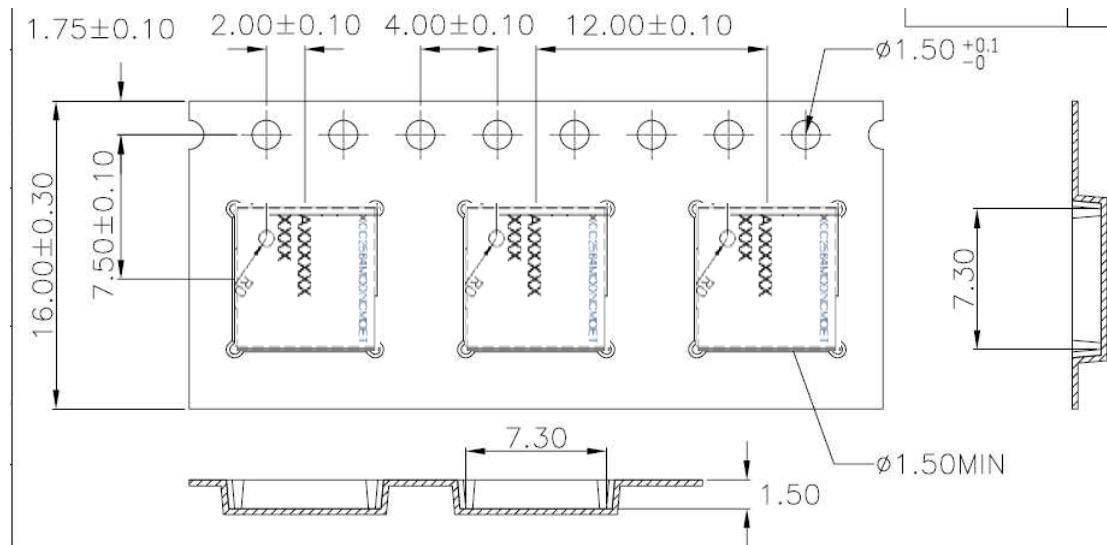
Figure 8-5 shows the insertion of the device.



**Figure 8-5. Insertion of Device**

### 8.2.2.4 Tape Specification

Figure 8-6 shows the dimensions of the tape.



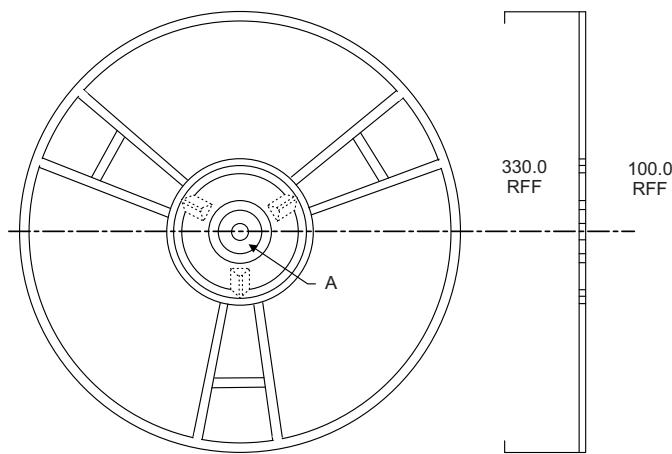
**Figure 8-6. Tape Dimensions (mm)**

- Cumulative tolerance of the 10-sprocket hole pitch is  $\pm 0.20$ .
- Carrier camber is within 1 mm in 250 mm.
- Material is black conductive polystyrene alloy.
- All dimensions meet EIA-481-D requirements.
- Thickness:  $0.30 \pm 0.05$  mm
- Packing length per 22-inch reel is 110.5 m (1:3).
- Component load per 13-inch reel is 2000 pieces.

### 8.2.2.5 Reel Specification

Figure 8-7 shows the reel specifications:

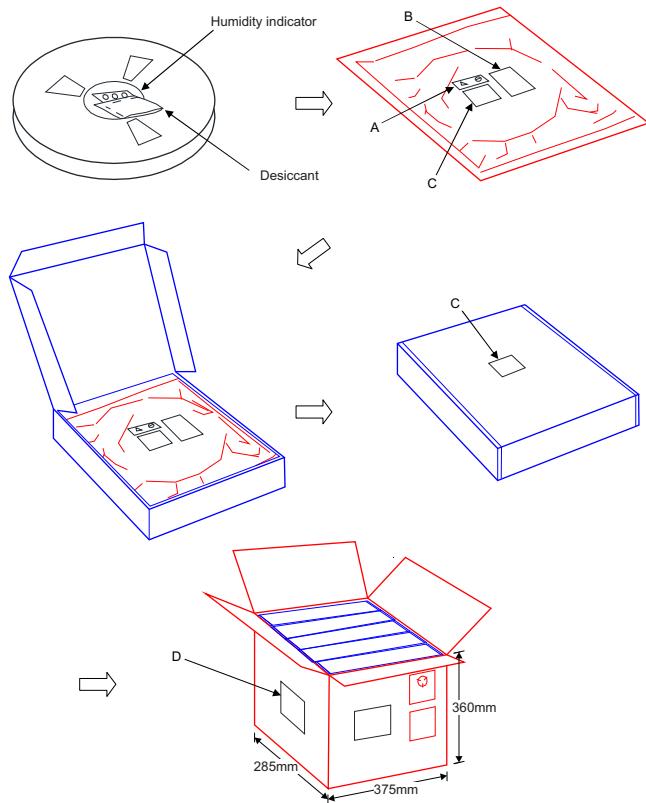
- 330-mm reel, 12-mm width tape
- Reel material: Polystyrene (static dissipative/antistatic)



**Figure 8-7. Reel Dimensions (mm)**

### 8.2.2.6 Packing Method

Figure 8-8 shows the reel packing method.

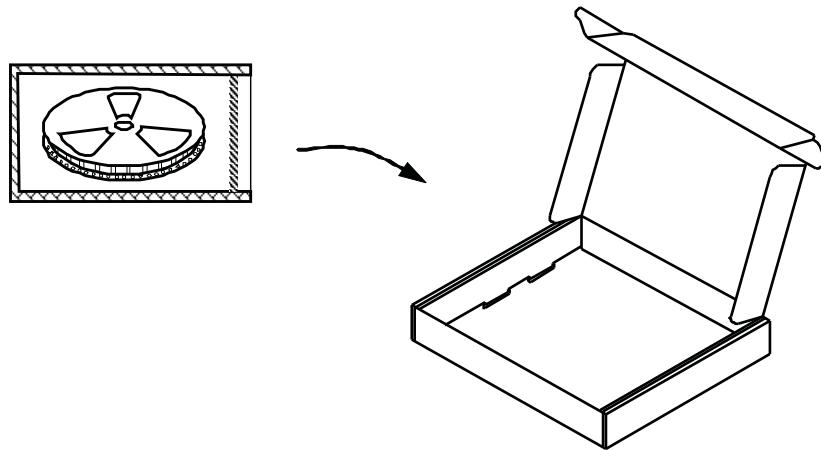


**Figure 8-8. Reel Packing Method**

### 8.2.2.7 Packing Specification

#### 8.2.2.7.1 Reel Box

Each moisture-barrier bag is packed into a reel box, as shown in Figure 8-9.



**Figure 8-9. Reel Box (Carton)**

### **8.2.2.7.2 Reel Box Material**

The reel box is made from corrugated fiberboard.

### **8.2.2.7.3 Shipping Box**

If the shipping box has excess space, filler (such as cushion) is added.

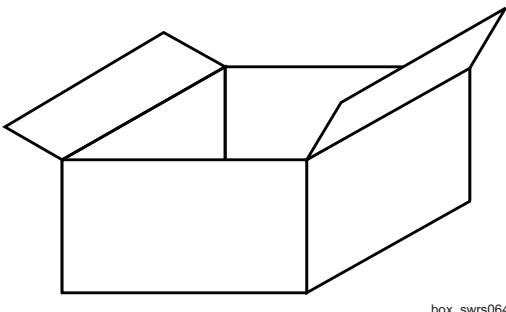
Figure 8-10 shows a typical shipping box.

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#### **NOTE**

The size of the shipping box may vary depending on the number of reel boxes packed.

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box\_swrs064

**Figure 8-10. Shipping Box (Carton)**

### **8.2.2.7.4 Shipping Box Material**

The shipping box is made from corrugated fiberboard.

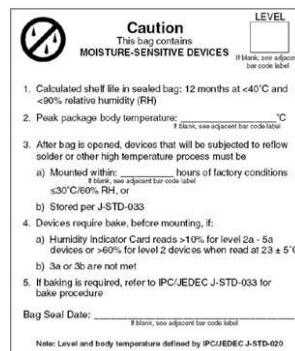
### **8.2.2.7.5 Labels**

Figure 8-11 shows the antistatic and humidity notice.



**Figure 8-11. Antistatic and Humidity Notice**

Figure 8-12 shows the MSL caution and storage condition notice.



**Figure 8-12. MSL Caution and Storage Condition Notice**

Figure 8-13 shows the label for the inner box.



Figure 8-13. Inner Box Label Example

### 8.2.3 Tray Packing Information (CC2564MODA Only)

#### 8.2.3.1 Tray Packing

Figure 8-14 shows the device in the tray.



Figure 8-14. Device in Tray

Figure 8-15 shows a close-up view of the device in the tray.

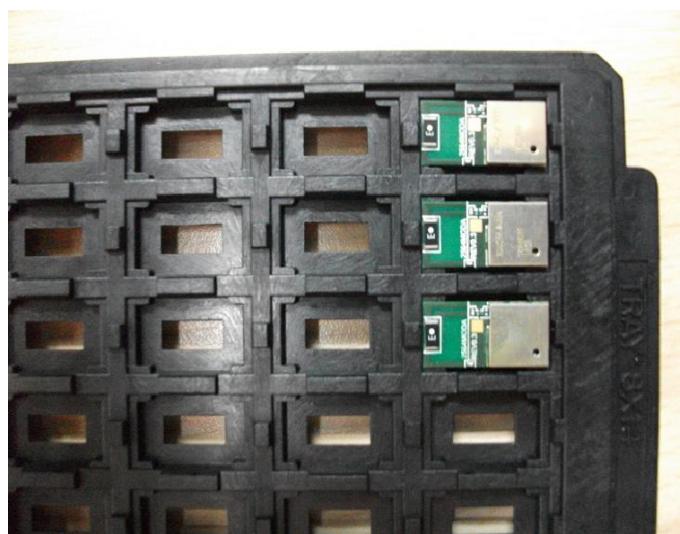
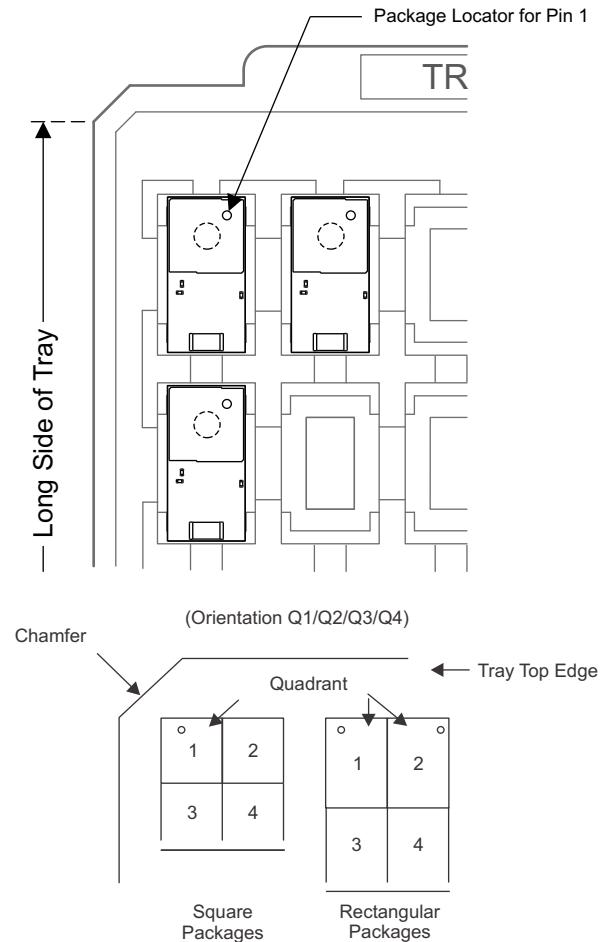


Figure 8-15. Close-Up View of Device in Tray

### 8.2.3.2 Pin 1 Orientation in Tray

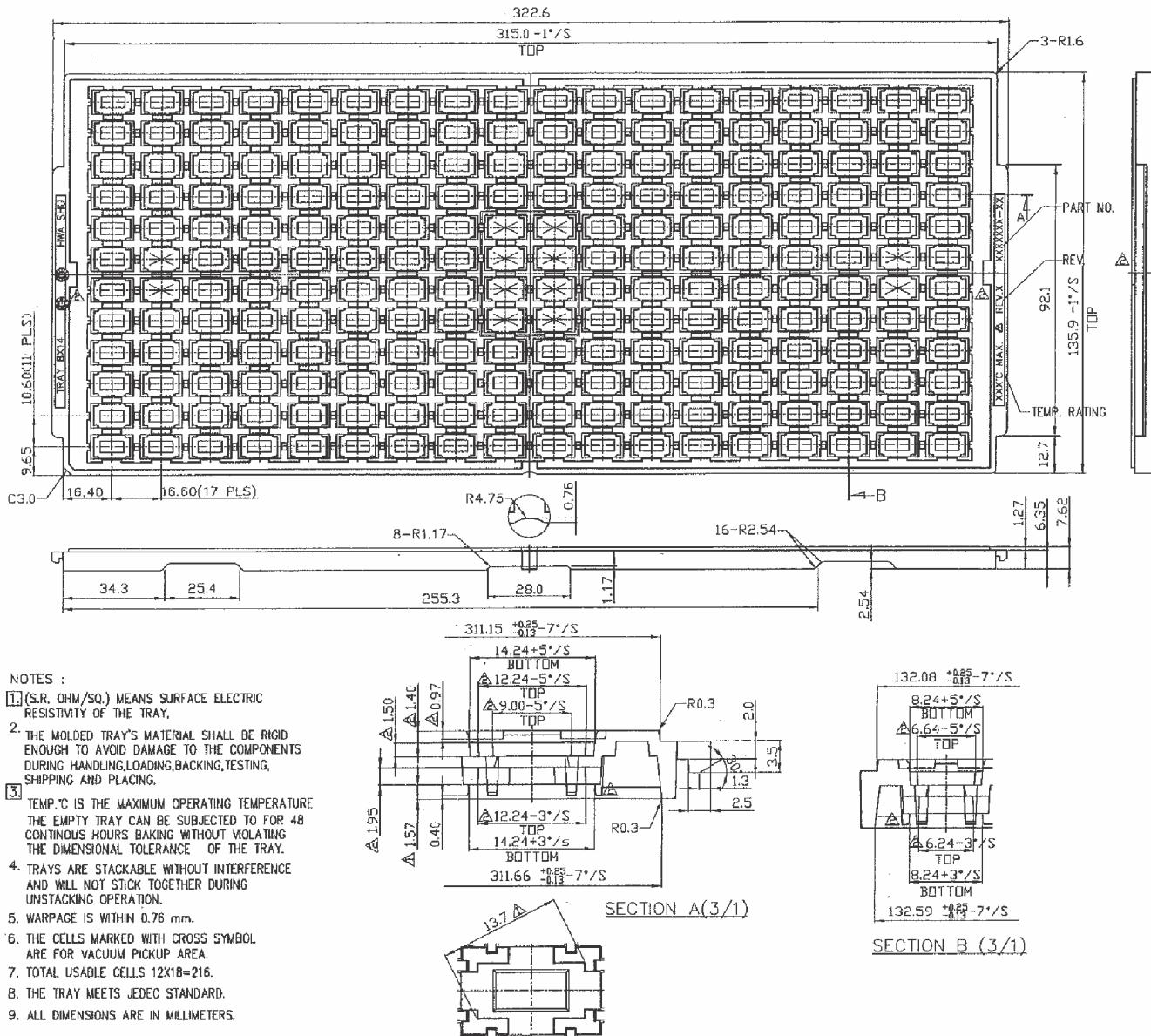
Figure 8-16 shows the Pin 1 orientation (Quadrant 2) of the CC2564MODA device in the tray.



**Figure 8-16. Pin 1 Orientation in Tray**

### 8.2.3.3 Tray Specification

Figure 8-17 shows the tray specifications. Table 8-3 lists a summary of the tray dimensions.



**Figure 8-17. Tray Dimensions**

**Table 8-3. Tray Dimensions**

DEVICE	PKG. TYPE	PKG. SIZE (mm)	TRAY PART NO.	TRAY MATRIX	TRAY LENGTH (mm)	TRAY WIDTH (mm)	POCKET SIZE (mm)	MAX. BAKE TEMP. (°C)
CC2564MODACMOG	MOG	7.0 x 14.0	EA70814-50	12 x 18	315.0	135.9	8.24 x 14.24	125

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Data Converters	<a href="http://dataconverter.ti.com">dataconverter.ti.com</a>
DLP® Products	<a href="http://www.dlp.com">www.dlp.com</a>
DSP	<a href="http://dsp.ti.com">dsp.ti.com</a>
Clocks and Timers	<a href="http://www.ti.com/clocks">www.ti.com/clocks</a>
Interface	<a href="http://interface.ti.com">interface.ti.com</a>
Logic	<a href="http://logic.ti.com">logic.ti.com</a>
Power Mgmt	<a href="http://power.ti.com">power.ti.com</a>
Microcontrollers	<a href="http://microcontroller.ti.com">microcontroller.ti.com</a>
RFID	<a href="http://www.ti-rfid.com">www.ti-rfid.com</a>
OMAP Applications Processors	<a href="http://www.ti.com/omap">www.ti.com/omap</a>
Wireless Connectivity	<a href="http://www.ti.com/wirelessconnectivity">www.ti.com/wirelessconnectivity</a>
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